











UCD90320

ZHCSFI3A -AUGUST 2016-REVISED SEPTEMBER 2016

UCD90320 32 轨 PMBus™ 电源排序器和系统管理器

1 特性

- 可对 24 个电压轨和 8 个数字轨进行排序、监视和 裕度调节
- 过压 (OV)、欠压 (UV)、过流 (OC)、欠流 (UC)、 过热、超时以及通用输入 (GPI) 触发的故障
- 提供灵活的排序开启/关闭相关性、延时、布尔逻辑和通用输入输出 (GPIO) 配置以支持复杂的排序 应用
- 4 个轨配置文件,用于自适应电压识别 (AVID) 稳压 器
- 高精度闭环裕度调节
- 主动微调功能,可改善电源轨输出电压精度
- 高级非易失性事件记录功能,可协助系统调试
 - 单一事件故障记录(100个条目)
 - 峰值记录
 - 黑盒故障记录,用于在首次发生故障时保存所有 电源轨和 I/O 引脚的状态
- 可轻松级联多达 4 个电源排序器并加以协调以提供 故障响应
- 可编程的看门狗定时器和系统复位
- 引脚选择电源轨状态
- 符合 PMBus™1.2 标准

2 应用

- 工业和自动测试设备 (ATE)
- 电信及网络设备
- 服务器和存储系统
- 需要对多个电源轨进行排序和监视的系统

3 说明

UCD90320 器件是一款采用紧凑型 0.8mm 间隙 BGA 封装的 32 轨 PMBus™可寻址电源排序器和系统管理器。

该器件集成有 24 条 ADC 通道,用于监视电源电压、电流和温度。GPIO 引脚共有 84 个,其中有 8 个可用于数字监视 (DMONx)、32 个可用于电源使能 (ENx)、24 个可用于裕度调节 (MARx)、16 个可用于逻辑 GPO、32 个可用于 GPI,此外还可用于级联及系统功能。

32 个 ENx 引脚和 16 个 LGPOx 引脚可配置为电平有效驱动或开漏输出。

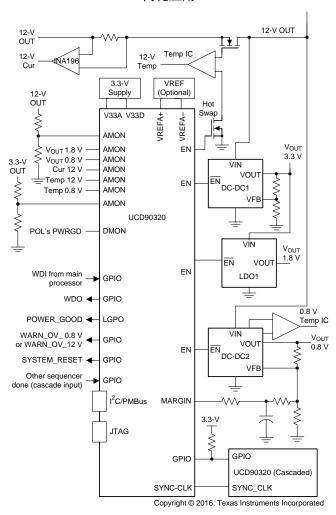
非易失性事件记录功能可在电源断电后保存故障事件。 黑盒故障记录功能会在首次发生故障后保存所有电源轨和 I/O 引脚的状态。凭借级联功能,通过一条 SYNC_CLK 引脚连接即可轻松管理多达 128 个电压 轨。故障引脚功能可对级联的各器件加以协调,以提供 同步的故障响应。引脚选择电源轨状态功能最多可通过 3 个 GPI 来控制多达 8 个用户定义的电源状态。这些 状态可实现高级配置和电源接口 (ACPI) 规范中列出的 系统低功耗模式。

器件信息(1)

器件型号	封装	封装尺寸 (标称值)
UCD90320	BGA (169)	12.0mm x 12.0mm

(1) 要了解所有可用封装,请见数据表末尾的可订购产品附录。

简化应用





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已更改 将数据表的状态从产品预览改为生产数据.......1

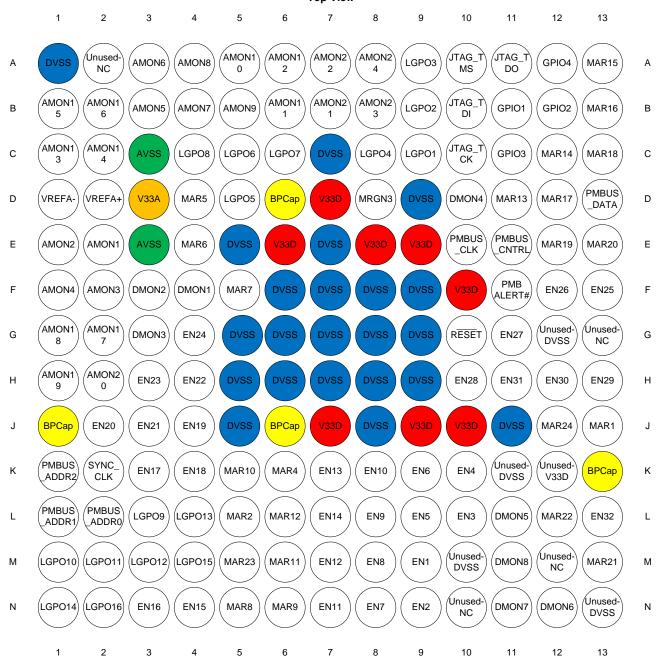


5 说明 (续)

TI Fusion Digital Power™设计软件是一款基于 PC 的直观图形用户界面 (GUI),可对所有系统工作参数进行配置、存储和监视。

6 Pin Configuration and Functions

ZWS Package 169-Pin BGA Top View





Pin Functions

PIN			Pin Functions
NAME	NO.	1/0	DESCRIPTION
ANALOG MONITOR			
AMON1	E2	ı	Analog input monitor pin
AMON2	E1	i	Analog input monitor pin
AMON3	F2	i	Analog input monitor pin
AMON4	F1	· ·	Analog input monitor pin
AMON5	B3	i	Analog input monitor pin
AMON6	A3	i	Analog input monitor pin
AMON7	B4	i	Analog input monitor pin
AMON8	A4	i	Analog input monitor pin
AMON9	B5	i	Analog input monitor pin
AMON10	A5	i	Analog input monitor pin
AMON11	B6	i	Analog input monitor pin
AMON12	A6	i	Analog input monitor pin
AMON13	C1	i	Analog input monitor pin
AMON14	C2	i	Analog input monitor pin
AMON15	B1	i	Analog input monitor pin
AMON16	B2	i	Analog input monitor pin
AMON17	G2	ı	Analog input monitor pin
AMON18	G1	i	Analog input monitor pin
AMON19	H1	ı	Analog input monitor pin
AMON20	H2	ı	Analog input monitor pin
AMON21	B7	ı	Analog input monitor pin
AMON22	A7	1	Analog input monitor pin
AMON23	B8	i	Analog input monitor pin
AMON24	A8	ı	Analog input monitor pin
ENABLE PINS			
EN1(GPIO)	M9	I/O	Digital output, rail enable signal or GPIO ⁽²⁾
EN2(GPIO)	N9	I/O	Digital output, rail enable signal or GPIO
EN3(GPIO)	L10	I/O	Digital output, rail enable signal or GPIO
EN4(GPIO)	K10	I/O	Digital output, rail enable signal or GPIO
EN5(GPIO)	L9	I/O	Digital output, rail enable signal or GPIO
EN6(GPIO)	K9	I/O	Digital output, rail enable signal or GPIO
EN7(GPIO)	N8	I/O	Digital output, rail enable signal or GPIO
EN8(GPIO)	M8	I/O	Digital output, rail enable signal or GPIO
EN9(GPIO)	L8	I/O	Digital output, rail enable signal or GPIO
EN10(GPIO)	K8	I/O	Digital output, rail enable signal or GPIO
EN11(GPIO)	N7	I/O	Digital output, rail enable signal or GPIO
EN12(GPIO)	M7	I/O	Digital output, rail enable signal or GPIO
EN13(GPIO)	K7	I/O	Digital output, rail enable signal or GPIO
EN14(GPIO)	L7	I/O	Digital output, rail enable signal or GPIO
EN15(GPIO)	N4	I/O	Digital output, rail enable signal or GPIO
EN16(GPIO)	N3	I/O	Digital output, rail enable signal or GPIO
EN17(GPIO)	K3	I/O	Digital output, rail enable signal or GPIO
EN18(GPIO)	K4	I/O	Digital output, rail enable signal or GPIO
EN19(GPIO)	J4	I/O	Digital output, rail enable signal or GPIO

⁽¹⁾ TI recommends placing a $200-\Omega$ resistor between analog input and monitor pins. (2) GPIO: GPI, Command GPO, WDI, WDO, system reset (RESET), FAULT pin for multiple chip cascading



Pin Functions (continued)

PIN				
NAME	NO.	I/O	DESCRIPTION	
EN20(GPIO)	J2	I/O	Digital output, rail enable signal or GPIO	
EN21(GPIO)	J3	I/O	Digital output, rail enable signal or GPIO	
EN22(GPIO)	H4	I/O	Digital output, rail enable signal or GPIO	
EN23(GPIO)	Н3	I/O	Digital output, rail enable signal or GPIO	
EN24(GPIO)	G4	I/O	Digital output, rail enable signal or GPIO	
EN25(GPIO)	F13	I/O	Digital output, rail enable signal or GPIO	
EN26(GPIO)	F12	I/O	Digital output, rail enable signal or GPIO	
EN27(GPIO)	G11	I/O	Digital output, rail enable signal or GPIO	
EN28(GPIO)	H10	I/O	Digital output, rail enable signal or GPIO	
EN29(GPIO)	H13	I/O	Digital output, rail enable signal or GPIO	
EN30(GPIO)	H12	I/O	Digital output, rail enable signal or GPIO	
EN31(GPIO)	H11	I/O	Digital output, rail enable signal or GPIO	
EN32(GPIO)	L13	I/O	Digital output, rail enable signal or GPIO	
CLOSED-LOOP MA	RGIN PINS			
MAR1(GPIO)	J13	I/O	Closed-loop margin PWM output or General GPIO	
MAR2(GPIO)	L5	I/O	Closed-loop margin PWM output or General GPIO	
MAR3(GPIO)	D8	I/O	Closed-loop margin PWM output or General GPIO	
MAR4(GPIO)	K6	I/O	Closed-loop margin PWM output or General GPIO	
MAR5(GPIO)	D4	I/O	Closed-loop margin PWM output or General GPIO	
MAR6(GPIO)	E4	I/O	Closed-loop margin PWM output or General GPIO	
MAR7(GPIO)	F5	I/O	Closed-loop margin PWM output or General GPIO	
MAR8(GPIO)	N5	I/O	Closed-loop margin PWM output or General GPIO	
MAR9(GPIO)	N6	I/O	Closed-loop margin PWM output or General GPIO	
MAR10(GPIO)	K5	I/O	Closed-loop margin PWM output or General GPIO	
MAR11(GPIO)	M6	I/O	Closed-loop margin PWM output or General GPIO	
MAR12(GPIO)	L6	I/O	Closed-loop margin PWM output or General GPIO	
MAR13(GPIO)	D11	I/O	Closed-loop margin PWM output or General GPIO	
MAR14(GPIO)	C12	I/O	Closed-loop margin PWM output or General GPIO	
MAR15(GPIO)	A13	I/O	Closed-loop margin PWM output or General GPIO	
MAR16(GPIO)	B13	I/O	Closed-loop margin PWM output or General GPIO	
MAR17(GPIO)	D12	I/O	Closed-loop margin PWM output or General GPIO	
MAR18(GPIO)	C13	I/O	Closed-loop margin PWM output or General GPIO	
MAR19(GPIO)	E12	I/O	Closed-loop margin PWM output or General GPIO	
MAR20(GPIO)	E13	I/O	Closed-loop margin PWM output or General GPIO	
MAR21(GPIO)	M13	I/O	Closed-loop margin PWM output or General GPIO	
MAR22(GPIO)	L12	I/O	Closed-loop margin PWM output or General GPIO	
MAR23(GPIO)	M5	I/O	Closed-loop margin PWM output or General GPIO	
MAR24(GPIO)	J12	I/O	Closed-loop margin PWM output or General GPIO	
GPIO AND CASCAI	DING PINS			
DMON1(GPIO)	F4	I/O	Digital input monitor pin or GPIO	
DMON2(GPIO)	F3	I/O	Digital input monitor pin or GPIO	
DMON3(GPIO)	G3	I/O	Digital input monitor pin or GPIO	
DMON4(GPIO)	D10	I/O	Digital input monitor pin or GPIO	
DMON5(GPIO)	L11	I/O	Digital input monitor pin or GPIO	
DMON6(GPIO)	N12	I/O	Digital input monitor pin or GPIO	
DMON7(GPIO)	N11	I/O	Digital input monitor pin or GPIO	



Pin Functions (continued)

		D-CODINTION		
NO.	I/O	DESCRIPTION		
M11	I/O	Digital input monitor pin or GPIO		
U.	1.			
B11	I/O	GPIO		
B12	I/O	GPIO		
C11	I/O	GPIO		
A12	I/O	GPIO		
K2	I/O	Synchronization clock I/O for multiple chip cascading		
C9	I/O	Logic GPO or GPIO		
В9	I/O	Logic GPO or GPIO		
A9	I/O	Logic GPO or GPIO		
C8	I/O	Logic GPO or GPIO		
D5	I/O	Logic GPO or GPIO		
C5	I/O	Logic GPO or GPIO		
C6	I/O	Logic GPO or GPIO		
C4	I/O	Logic GPO or GPIO		
L3	I/O	Logic GPO or GPIO		
M1	I/O	Logic GPO or GPIO		
M2	I/O	Logic GPO or GPIO		
M3	I/O	Logic GPO or GPIO		
L4	I/O	Logic GPO or GPIO		
N1	I/O	Logic GPO or GPIO		
M4	I/O	Logic GPO or GPIO		
N2	I/O	Logic GPO or GPIO		
ERFACE				
E10	I	PMBus clock (must pull up to V33D)		
D13	I/O	PMBus data (must pull up to V33D)		
F11	0	PMBus alert, active-low, open-drain output (must pull up to V33D)		
E11	I	PMBus control pin		
L2	I	PMBus digital address input. Bit 0		
L1	I	PMBus digital address input. Bit 1		
K1	ı	PMBus digital address input. Bit 2		
•				
A10	I	Test mode select with internal pull-up		
C10	I	Test clock with internal pull-up		
A11	0	Test data out with internal pull-up		
B10	ı	Test data in with internal pull-up		
ROUND, AND I	EXTERNAL	REFERENCE PINS		
G10	I	Active-low device reset input. Pull up to V33D.		
D3	1	Analog 3.3-V supply. Decouple from V33D to minimize the electrical noise contained on V33D from affecting the analog functions.		
D7, E6, E8, E9, F10, J7, J9, J10	I	Digital 3.3-V supply for I/O and some logic.		
D6, J1, J6, K13	I	Positive supply for most of the logic function, including the processor core and most peripherals. The voltage on this pin is 1.2 V and is supplied by the on-chip LDO. The BPCap pins should only be connected to each other and an external capacitor as specified in <i>On-Chip Low Drop-Out (LDO) Regulator</i> section of the Electrical Characteristics table.		
	M11 B11 B12 C11 A12 K2 C9 B9 A9 C8 D5 C5 C6 C4 L3 M1 M2 M3 L4 N1 M4 N2 ERFACE E10 D13 F11 E11 L2 L1 K1 A10 C10 A11 B10 ROUND, AND II ROUND, AND II ROUND, J7, J9, J10 D6, J1, J6,	M11		



Pin Functions (continued)

	` '					
PIN		1/0	DESCRIPTION			
NAME	NO.	I/O	DESCRIPTION			
AVSS	C3, E3	I	Analog ground. These are separated from DVSS to minimize the electrical noise contained on V33D from affecting the analog functions.			
DVSS	A1, C7, D9, E5, F9, H5, H9, J5, J8, J11, H6, H7, H8, G5, G6, G7, G8, G9, F6, F7, F8, E7	I	Ground reference for logic and I/O pins.			
VREFA+	D2	I	(Optional) positive node of external reference voltage			
VREFA-	D1	1	(Optional) negative node of external reference voltage			
UNUSED PINS						
UNUSED-NC	A2, G13, M12, N10	-	Do not connect. Leave floating or isolated.			
UNUSED-DVSS	G12, K11, M10, N13	_	Tie to DVSS.			
UNUSED-V33D	K12	-	Tie to V33D.			



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Cumply voltage	V33D to DVSS	0	4	V
Supply voltage	V33A to AVSS	0	4	V
Input voltage	on all I/O pins except PMBUS_CNTRL, PMBALERT, MARGIN19, and MARGIN20, regardless of whether the device is powered (2)	-0.3	5.5	V
Input voltage	PMBUS_CNTRL, PMBALERT, MARGIN19, and MARGIN20	-0.3	V _{V33D} + 0.3	V
Output current	Maximum current per output pin		25	mA
Operating junction te	mperature, T _J	TBD	150	°C
Storage temperature	, T _{stg}	-65	150	°C

⁽¹⁾ Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those listed in the *Recommended Operating Conditions* table. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	\/
V _(ESD)	discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{V33D}	Cumply input valtage	3.15	3.3	3.63	٧
V _{V33A} ⁽¹⁾	Supply input voltage	2.97	3.3	3.63	V
T _A	Operating ambient temperature	-40		85	°C
T _C	Operating case temperature	-40		90	٥°
T_J	Operating junction temperature	-40		93	°C

⁽¹⁾ It is recommended to connect the V33A pin and the V33D pin to the same supply. V33A must be powered before V33D if sourced from different supplies. There is no restriction on the ordering sequence for powering off.

⁽²⁾ Applies to static and dynamic signals including overshoot.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



7.4 Thermal Information

		UCD90320	
	THERMAL METRIC ⁽¹⁾	ZWS (BGA)	UNIT
		169 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance (2)(3)	41.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance (2)	15.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance (2)(4)(5)	18.9	°C/W
ΨЈТ	Junction-to-top characterization parameter (6)	0.3	°C/W
ΨЈВ	Junction-to-board characterization parameter (4)	20.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	n/a	°C/W

- (1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.
- Junction to ambient thermal resistance (θ_{JA}), junction to board thermal resistance (θ_{JB}), and junction to case thermal resistance (θ_{JC}) numbers are determined by a package simulator.

- $T_{J} = T_{A} + (P \times \theta_{JA})$ $T_{J} = T_{PCB} + (P \times \Psi_{JB})$ $T_{J} = T_{B} + (P \times \theta_{JB})^{(j)}$ $T_{J} = T_{C} + (P \times \Psi_{JT})$ (5)

7.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT					
I _{V33}	Supply Current	$V_{V33D} = V_{V33A} = 3.3 \text{ V}$		31.4	54.9	mA
ON-CHIP	LOW DROP-OUT (LDO) REGULATOR					
C_{LDO}	External filter capacitor size for internal power supply ⁽¹⁾		2.5		4	μF
V_{LDO}	LDO output voltage		1.08	1.2	1.32	V
I _{INRUSH}	Inrush current		50		250	mA
ANALOG	-TO-DIGITAL CONVERTER (ADC) ⁽²⁾⁽³⁾					
V33A	ADC supply voltage		2.97	3.3	3.63	V
AVSS	ADC ground voltage			0		V
C _{V33A}	Voltage reference decoupling capacitance between V33A and AVSS (if using internal reference) (4)			1.01		μF
V_{REFA+}	Positive external voltage reference on VREFA+ pin		2.4		3	V
V_{REFA}	Negative external voltage reference on VREFA- pin		V _{AVSS}	AVSS	0.3	V
C _{REF}	Voltage reference decoupling capacitance between VREFA+ and VREFA- (if using external reference) ⁽⁴⁾			1.01		μF
\/	Analog input range, internal reference (5)		0		V33A	V
V_{ADCIN}	Analog input range, external reference (6)		V _{VREFA}		V _{VREFA+}	V
IL	ADC input leakage current				2	μΑ
R _{ADC}	ADC equivalent input resistance				2.5	kΩ
C _{ADC}	ADC equivalent input capacitance				10	pF
F _{CONV}	ADC conversion rate (on each ADC channel) ⁽¹⁾			1		MSPS

- Connect the capacitor as close as possible to pin D6.
- Total of two ADC channels run independently during normal operation.
- Total unadjusted error is the maximum error at any one code versus the ideal ADC curve. It includes offset error, gain error, and INL at any given ADC code.
- Two capacitors (1.0 μF and 0.01 μF) connected in parallel.
- Internal reference is connected directly between V33A and AVSS.
- External reference noise level must be under 12 bit (-74 dB) of full scale input, over input bandwidth, measured at VREFA+ VREFA+.



Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
N	ADC resolution			12		bits
L	Total unadjusted error, over full input rangea when using internal reference			±10	±30	LSB
E _T	Total unadjusted error, over full input range when using external reference			±2.5	±4	LOD
DIGITAL IN	IPUTS AND OUTPUTS (GPIO, Logic GPO, E	N, AND MARGIN PINS)				
V _{IH}	I/O high-level input voltage ⁽⁷⁾		0.65 × V _{V33D}		5.5	V
V _{IL}	I/O low-level input voltage		0		0.35 x V _{V33D}	V
V _{HYS}	I/O input hysteresis		0.2			V
V _{OH}	I/O high-level output voltage		2.4			V
V _{OL}	I/O low-level output voltage				0.4	V
I _{OH}	High-level source current	$V_{OH} = 2.4 V^{(8)}$	4			mA
I _{OL}	Low-level sink current	$V_{OL} = 0.4 V^{(8)}$	4			mA
RESET AN	D BROWNOUT					
V33DSlew	Minimum V33D slew rate between 2.8 V and 3.2 V		0.1			V/ms
V _{RESET}	Supply voltage at which device comes out of reset		2.85	3	3.15	V
V_{BOR}	Supply voltage at which device enters brownout		2.93	3.02	3.11	V
V _{SHDN}	Supply voltage at which device shuts down		2.7	2.78	2.87	V
t _{RESET}	Minimum low-pulse width needed at RESET pin			250		ns
t _{IRT}	Internal reset time (9)			9	11.5	ms

- PMBUS_CNTRL, $\overline{PMBALERT}$, MARGIN19 and MARGIN20 pins have V_{V33D} + 0.3 V as maximum input voltage rating. Io specifications reflect the maximum current where the corresponding output voltage meets the V_{OH}/V_{OL} thresholds. If power-loss or brown-out event occurs during an EEPROM program or erase operation, and EEPROM needs to be repaired (which is a rare case), the internal reset time may be longer.

7.6 Non-Volatile Memory Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
CONFIGUR	RATION FLASH MEMORY				
PE _{CYC}	Number of program and erase cycles before failure		100,000		Cycles
T _{RET}	Data retention	-40 °C $\leq T_J \leq 85$ °C	20		Years
FAULT AN	D EVENT LOGGING EEPROM				
EPE _{CYC}	Number of mass program and erase cycles of a single word before failure		500,000		Cycles
ET _{RET}	Data retention	-40°C ≤ T _J ≤ 85°C	20		Years



7.7 I²C/PMBus Interface Timing Requirements

			MIN	NOM	MAX	UNIT
I 1	t _(HD:STA)	Start condition hold time	450			ns
12	t _(LOW)	Clock low period ⁽¹⁾	450			ns
13	t _r	Clock rise time and data rise time (2)			See ⁽²⁾	ns
14	t _(HD:DAT)	Data hold time		25		ns
15	t _f	Clock fall time and data fall time (3)		112.5	125	ns
16	t _(HIGH)	Clock high time	300			ns
17	t _(SU:DAT)	Data setup time	225			ns
18	t _(SU:STA)	Start condition setup time (repeated start only)	450			ns
19	t _(SU:STO)	Stop condition setup time	300			ns
I10	t _(DV)	Data valid		25		ns

- (1) PMBus host must support clock stretching per *PMBus Power System Management Protocol Specification Part I General Requirements, Transport and Electrical Interface, Revision 1.2, Section 5.2.6.*
- (2) Because the I2CSCL signal and the I2CSDA signal operate as open-drain-type signals, which the controller can actively drive only "Low", the time that either signal takes to reach a high level depends on external signal capacitance and pull-up resistor values.
- (3) Specified at a nominal 50-pF load.

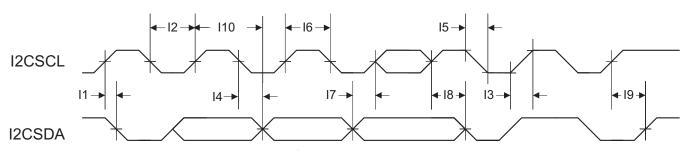
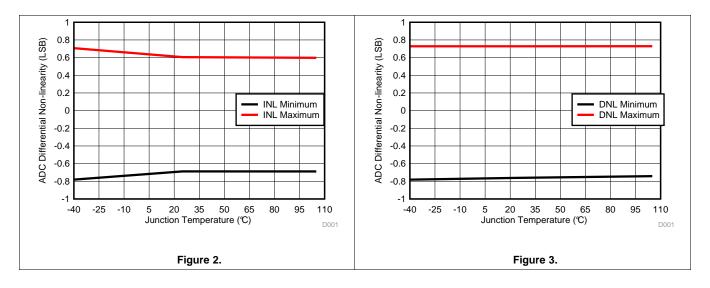


Figure 1. I²C/PMBus Timing Diagram

TEXAS INSTRUMENTS

7.8 Typical Characteristics





8 Detailed Description

8.1 Overview

Electronic systems such as CPU, DSP, microcontroller, FPGA, and ASIC can have multiple voltage rails and require certain power-ON and power-OFF sequences in order to function correctly. The UCD90320 device can control up to 32 voltage rails and ensure correct power sequences during normal condition and fault conditions.

In addition to sequencing, the device can continuously monitor rail voltages, currents, temperatures, fault conditions, and report the system health information to upper computers through a PMBus interface, improving long term reliability.

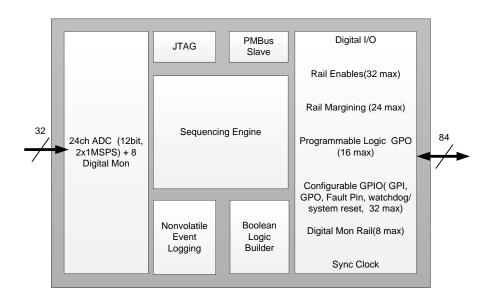
The device can protect electronic systems by responding to power system faults. The fault responses are conveniently configured by users through Fusion GUI. Fault events are stored in on-chip nonvolatile flash memory in order to assist failure analysis. A Black Box Fault Log feature stores comprehensive system statuses at the moment when the first fault occurs. With this feature, failure analysis can be more effective.

System reliability can be improved through four-corner testing during system verification. During four-corner testing, each voltage rail is required to operate at the minimum and maximum output voltages, commonly known as margining. The device can perform accurate closed-loop margining for up to 24 voltage rails. During normal operation, UCD90320 can also actively trim DC output voltages using the same margining circuitry. This feature allows tuning rail voltages to an optimal level.

The UCD90320 device supports control environments via both PMBus interface and pin-based interface. The device functions as a PMBus slave. It can communicate with upper computers with PMBus commands, and control voltage rails accordingly. In addition to rail enable (EN) pins, up to 32 GPIO pins can be configured as GPOs and directly controlled by PMBus commands. The device can be controlled by up to 32 GPIO configured GPI pins. The GPIs can be used as fault inputs which can shut down rails. The GPIs can be also used as Boolean logic input to control the 16 Logic GPO outputs. Each of the 16 Logic GPO pins has a flexible Boolean logic builder. Input signals of the Boolean logic builder can include GPIs, other GPOs, and selectable system flags such as POWER_GOOD, faults, warnings, and so forth. A simple state machine is also available for each Logic GPO pin.

The device provides additional features such as cascading, pin-selected states, system watchdog, system reset, run time clock, peak value log, reset counter, and so forth. Cascading feature offers convenient ways to cascade up to 4 UCD90320 devices and manage up to 128 voltage rails through one SYNC_CLK pin connection. Pin-selected states feature allows users to define up to 8 rail states. These states can implement system low-power modes as set out in the *Advanced Configuration and Power Interface (ACPI)* specification. The *Feature Description* section of this datasheet describes other device features.

8.2 Functional Block Diagram





8.3 Feature Description

8.3.1 TI Fusion GUI

The Texas Instruments Fusion Digital Power Designer software allows the user to configure the device. This PC-based graphic user interface (GUI) offers an intuitive I²C and PMBus interface to the device. The Fusion GUI allows the design engineer to configure the system operating parameters for the application without directly using PMBus commands, store the configuration to on-chip nonvolatile memory, and observe system status (voltage, current, temperature, faults, and so forth). This data sheet references the Fusion Digital Power Designer software is as Fusion GUI and many sections include screenshots. Download the Fusion GUI from TI here. After configuration, the device can perform all designed functions independently without further need for the Fusion GUI.

8.3.2 PMBUS Interface

PMBus refers to a serial interface specifically designed to support power management. The PMBus interface is based on the SMBus interface that is built on the I²C physical specification. The UCD90320 device supports revision 1.2 of the PMBus standard. Wherever possible, standard PMBus interface commands support the function of the device. Unique features of the device are defined to configure or activate via the MFR_SPECIFIC commands. These commands are defined in the, *UCD90320 Sequencer and System Health Controller PMBUS Command Reference*. The most current UCD90320 PMBus™ Command Reference can be found within the TI Fusion Digital Power Designer software through the Help Menu (Help, Documentation & Help Center, Sequencers tab, Documentation section).

This data sheet makes frequent mention of the PMBus specification. Specifically, this document is *PMBus Power System Management Protocol Specification Part II – Command Language*, Revision 1.2, dated 6 September 2010. The specification is published by the Power Management Bus Implementers Forum and is available from www.pmbus.org.

The UCD90320 device meets all of the requirements of the *Compliance* section of the PMBus specification. The firmware complies with the SMBus 1.2 specification, including support for the SMBus ALERT function. The hardware supports either 100-kHz or 400-kHz PMBus operation.

8.3.3 Rail Setup

Power rails are defined under the **Pin Assignment** tab, as shown in Figure 4. Click corresponding buttons to add or delete a rail. After a rail is added, AMON, DMON, EN, and MARGIN pins can be assigned to the rail. UCD90320 has 24 AMON pins, 8 DMON pins, 32 EN pins, and 24 MARGIN pins, thus can support up to 32 rails.

Rails - M	onitors & Enable	s					5 of 24 Assigned
	Rail Name	Voltage	Temperature	Current	Enable	Trim/Margin PWM	Actions
Rail #1	Rail #1	Pin E1 MON 01	<click assign="" to=""></click>	<click assign="" to=""></click>	Pin M9 EN 01	Pin J13 PWM 01	Delete Configure
Rail #2	Rail #2	Pin E2 MON 02	<click assign="" to=""></click>	<click assign="" to=""></click>	Pin N9 EN 02	Pin L5 PWM 02	Delete Configure
Rail #3	Rail #3	Pin F2 MON 03	<click assign="" to=""></click>	<click assign="" to=""></click>	Pin L 10 EN 03	Pin D8 PWM 03	Delete Configure
Rail #4	Rail #4	Pin F1 MON 04	<click assign="" to=""></click>	<click assign="" to=""></click>	Pin K10 EN 04	Pin K6 PWM 04	Delete Configure
Rail #5	Rail #5	Pin B3 MON 05	<click assign="" to=""></click>	<click assign="" to=""></click>	Pin L9 EN 05	Pin D4 PWM 05	Delete Configure
Add Rai	1						

Figure 4. Fusion GUI Rail Setup Window (Configure ▶ Pin Assignment tab)



8.4 Device Functional Modes

8.4.1 Rail Monitoring Configuration

After rails are set up in the **Pin Assignment** tab, they are visible under the **Vout Config** tab, as shown in Figure 5. The initial voltage values are 0.

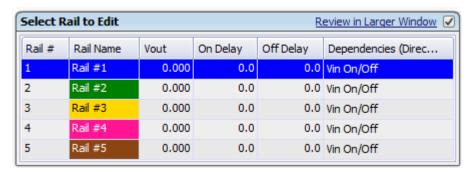


Figure 5. Rail Selection Window (Rail Configuration)

Configure the voltage monitoring parameters of the selected rail under the **Vout Config** tab. Figure 6 shows the configuration window..

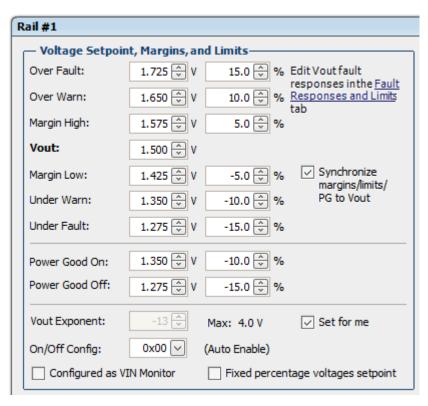


Figure 6. Rail Voltage Configuration Window (Rail Configure, Vout Config tab)

When a AMON pin is assigned in Figure 4 to monitor the voltage of a particular a rail, a fault or warn event occurs when the monitored rail voltage exceeds the voltage window defined by the *Over and Under Warn/Fault* thresholds. When a fault is detected, the device responds with user-defined actions. See also the *Fault Responses Configuration* section for more details.

Rail Profile is composed of a group of nine thresholds set by: VOUT_COMMAND, VOUT_OV_FAULT_LIMIT, VOUT_OV_WARNING_LIMIT, VOUT_MARGIN_HIGH, POWER_GOOD_ON, VOUT_MARGIN_LOW, POWER_GOOD_OFF, VOUT_UV_WARNING_LIMIT and VOUT_UV_FAULT_LIMIT.



Device Functional Modes (continued)

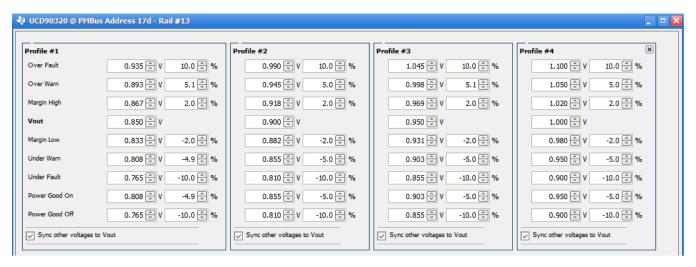


Figure 7. Rail Profile Configurations (Rail Config ▶ Edit Rail Profiles)

The device offers 50 individual profiles shared among all 24 AMON voltage rails. Each AMON voltage rail can have at least one but no more than 4 profiles. The profiles are controlled by 2 GPIs as shown in Figure 8. A programmable block-out period is used to block all voltage related faults on the given rail when profile is changed.

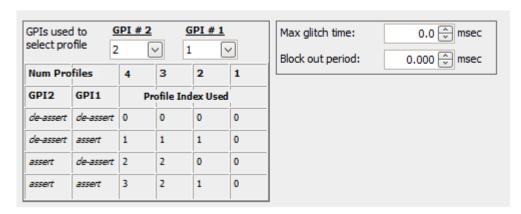


Figure 8. Rails Profile Selection Through GPIs (Rail Config ► Edit Rail Profiles)

The device supports digital monitor. If a DMON pin is assigned in Figure 7 to monitor POWER_GOOD of POL. The DMON rail has no rail profile. If the DMON input is logic HIGH, the rail is POWER_GOOD, otherwise the rails has UV fault or warns and is at POWER_NOT_GOOD.

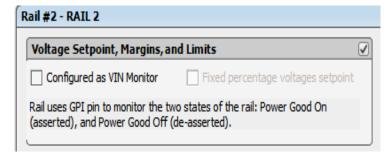


Figure 9. Digital Rail Configuration Window



Device Functional Modes (continued)

Vout Exponent defines the voltage value resolution according to PMBus linear data format. Fusion GUI can automatically select optimal *Vout Exponent* value to cover the required voltage range with the finest possible resolution. For more information regarding PMBus linear data format, refer to PMBus specification mentioned at the beginning of this section.

On/Off Config defines a rail turn-ON and turn-OFF command:

- None (Auto enable). Rail always seeks to turn-ON as long as UCD90320 is powered.
- CONTROL Pin Only. Rail seeks to turn-ON and turn-OFF according to PMBus CONTROL line (asserted/deasserted).
- OPERATION Only. Rail seeks to turn-ON and turn-OFF according to PMBus OPERATION command (On/Off).
- Both CONTROL pin and OPERATION. Rail seeks to turn-ON when CONTROL pin is asserted, AND PMBus OPERATION command sets the rail to On. Rail seeks to turn-OFF when OPERATION command sets the rail to OFF, OR when CONTROL line is de-asserted.

After receiving a turn ON or turn OFF command, a rail examines a series of conditions before asserting or deasserting its EN pin. Conditions include *Rail Sequence On/Off Dependency*, *GPI Sequence On/Off Dependency*, *Turn-On/Off Delay*, as shown in *Rail Sequence Configuration* section.

Fixed percentage voltages setpoint, when checked, configures a rail into adaptive voltage scaling technology (AVS) mode. The *Vout Setpoint* can be dynamically set by PMBus during operation in order to achieve energy saving. The rail warn and fault voltage thresholds maintain fixed ratios with respect to the *Vout Setpoint*. Due to the fact that the power supply and UCD90320 device may not change *Vout Setpoint* simultaneously or with the same slew rate, the device takes the following steps to avoid false-triggering warn and fault. If the new *Vout Setpoint* is higher than the current *Vout Setpoint*, the OV warn and fault thresholds are immediately set to their respective new levels. Other thresholds are initially maintained, and then increase by 20-mV step size in every 400 μs until the new levels are reached. If the new *Vout Setpoint* is lower than the current *Vout Setpoint*, the UV warn and fault and Power Good On and Power Good Off thresholds are immediately set to their respective new levels. Other thresholds are initially maintained, and then decrease by 20-mV step size every 400 μs until the new levels are reached. Table 1 summarizes the thresholds adjustment scheme in AVS mode.. This feature is not available for DMON pin.

Table 1. Thresholds Adjustment Scheme in AVS Mode

TRANSITION	IMMEDIATE UPDATE	ADJUSTMENT ⁽¹⁾		
New Vout Setpoint to Current Vout Setpoint	OV fault and warn notification	UV fault and warn notification, Margin High and Margin Low, Power Good On and Power Good Off		
,	UV fault and warn notification, Power Good On and Power Good Off	OV fault and warn notification, Margin High and Margin Low,		

(1) Gradual adjustment towards new levels with 2-0mV step size and 400-µs step interval

Current and temperature monitoring parameters of the selected rail can be configured under the **Fault Responses and Limits** tab. First select a rail in the top-right corner of the FUSION GUI, and then edit the current and temperature monitoring parameters as shown in Figure 10.

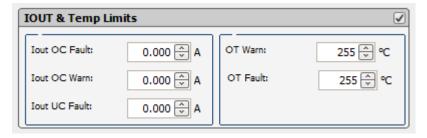


Figure 10. Current and Temperature Limits Configuration Window (Rail Config ► IOUT and Temperature Limits)

Each rail has a Power Good status determined by the following rules.



- If rail voltage is monitored by an AMON pin, the *Power Good* status is solely determined by *Power Good On* and *Power Good Off* thresholds as shown in Figure 6. A rail is given *Power Good* status if its rail voltage is above the *Power Good On* threshold. Otherwise, the rail is given *Not Power Good* status if the rail voltage is below the *Power Good Off* threshold. The rail remains in the current status if its voltage is neither above *Power Good On* nor below *Power Good Off* thresholds.
- If rail voltage is not monitored by a AMON or DMON pin, the *Power Good* status is determined by the turn-ON and turn-OFF eligibility of the rail. A rail is immediately given *Power Good* status when the rail meets all the turn-on conditions set by the user, such as *On and Off Config*, dependencies and delays. Similarly, a rail is immediately given *Not Power Good* status when the rail meets all the turn-off conditions set by the user. The behavior is the same regardless whether a physical EN pin is assigned to the rail.

The Power Good status is not affected by any warnings and faults unless the fault response is to turn OFF the rail.

UV fault and warn notification is ignored when a rail is off. UV fault and warn notification is also ignored during start up until the rail enters *Power Good* status for the first time. This mechanism avoids false-triggering UV fault and warn notification when the rail voltage is expected to be below UV thresholds.

A *Graceful Shutdown* feature is enabled by checking the *Configured as VIN Monitor* checkbox. When enabled, the rail is configured to monitor VIN. When VIN drops below *Power Good Off* threshold, the device ignores any UV fault and warn notifications on any other rail.

8.4.2 GPI Configuration

Up to 32 of the 84 GPIO pins of the UCD90320 device can be configured as GPI. The GPI configuration window is under the **Pin Assignment** tab. Figure 11 shows an example.

GPIs - General Pur	pose Inputs			5 of 24 Assigned
GPI Name	Pin	Polarity	Special Behavior	Actions
GPI #1	Pin L4 GPIO 01	Active High		<u>Delete</u> <u>Configure</u>
GPI #2	Pin N1 GPIO 02	Active High		<u>Delete</u> <u>Configure</u>
GPI #3	Pin M4 GPIO 03	Active High		<u>Delete</u> <u>Configure</u>
GPI #4	Pin N2 GPIO 04	Active High		<u>Delete</u> <u>Configure</u>
GPI #5	Pin G3 GPIO 05	Active High		<u>Delete</u> <u>Configure</u>
Add GPI				

Figure 11. GPI Configuration Window (Hard Configuration ▶ Monitors and GPIO Pins Assignment)

The polarity of GPI pins can be configured to be either active high or active low. Each GPI can be used as a source of sequence dependency. (See also the *Rail Sequence Configuration* section). The GPI pins can be also used for cascading function. (See also the *Cascading Multiple Devices* section). The first defined 3 GPIs regardless of their main purpose are assigned to the pin selected states function. (See also the *Pin Selected Rail States Configuration* section).

In addition hard configuration functions, four special behaviors can be assigned to each GPI pin using the dropdown window shown in Figure 12:

- **GPI Fault** The de-assertion of this pin is treated as a fault, which can trigger shut-down actions for any voltage rails. (See also the *Fault Responses Configuration* section).
- Latched Statuses Clear Source This pin can be used to clear latched-type statuses (_LATCH). (See also the GPO Configuration section).
- Input Source for Margin Enable When this pin is asserted, all rails with margining enabled enter into a margined state (low or high). This special behavior can be assigned to only one GPI.
- Input Source for Margin Low and Not-High When this pin is asserted, all margined rails are set to Margin Low as long as the Margin Enable is asserted. When this pin is de-asserted the rails are set to Margin High as long as the Margin Enable is asserted. This special behavior can be assigned to only one GPI.
- Configured as Debug Pin When the pin is asserted, the device does not alert the PMBALERT pin, and neither responds to, nor logs any faults as defined in Table 2. The device ignores the rail sequence ON and OFF dependency conditions. As soon as the sequence ON and OFF timeout expires, the rails are sequenced



ON or OFF accordingly regardless of the timeout action. If the sequence ON or OFF timeout value is set to 0, the rails are sequenced ON or OFF immediately. The fault pins do not pull the fault bus low. LGPOs affected by these events return to the original states.

• Configured as Fault Pin GPI fault enable functionality must be set to enable this feature. When set, if there is no fault on a fault bus. The FAULT pin is digital input pin and it monitors the fault bus. When one or more UCD90329 devices detect a rail fault, the corresponding FAULT pin is turned into active driven low state, pulling down the fault bus voltage and informing all other UCD90320 devices of the corresponding fault. This behavior allows a coordinated action to be taken across multiple devices. After the fault is cleared, the state of the FAULT pin reverts to that of an input pin.(See also the Cascading Multiple Devices section).

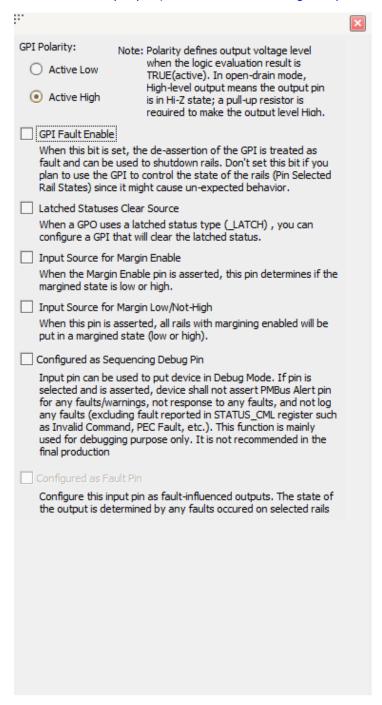


Figure 12. GPI Configuration Dropdown Window (Hardware Configuration ► Monitor and GPIO Pins Assignment)



Table 2. List of Events Affected by Debug Mode

Events	Description
VOUT_OV_FAULT	Voltage rail is over OV fault threshold
VOUT_OV_WARNING	Voltage rail is over OV warning threshold
VOUT_UV_FAULT	Voltage rail is under UV fault threshold
VOUT_UV_WARNING	Voltage rail is under UV warning threshold
TON_MAX	Voltage rail fails to reach power good threshold in predefined period.
TOFF_MAX Warning	Voltage rail fails to reach power not good threshold in predefined period
IOUT_OC_FAULT	Current rail is over OC fault threshold
IOUT_OC_WARNING	Current rail is under OC warning threshold
IOUT_UC	Current rail is under UC fault threshold
OT_FAULT	Temperature rail is over OT fault threshold
OT_WARNING	Temperature rail is over OT warning threshold
All GPI de-asserted	No logging and fault response, but the function of the GPI is not ignored.
SYSTEM_WATCHDOG_TIMEOUT	System watch timeout
RESEQUENCE_ERROR	Rail fails to resequence
SEQ_ON_TIMEOUT	Rail fails to meeting sequence on dependency in predefined period
SEQ_OFF_TIMEOUT	Rail fails to meeting sequence on dependency in predefined period
SLAVE_FAULT	Rail is shut down due to that its master has fault



8.4.3 Rail Sequence Configuration

Rail sequences can be configured via the **Vout Config** tab. First, select a rail in the top-right corner of the Fusion GUI, and then edit the rail sequence as shown in Figure 13.



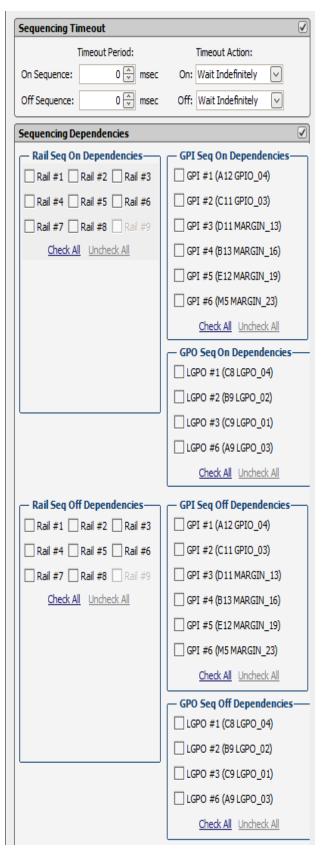


Figure 13. Rail Sequence Configuration Window (Rail Config)



When a rail receives a turn-ON or turn-OFF command as defined in *On/Off Config*, it checks its dependency conditions. When all dependencies are fulfilled, the rail then waits for a *Turn ON Delay* time or a *Turn OFF Delay* time, and then asserts or de-asserts the EN pin.

The device fulfills a *Rail Sequence On Dependency* status when the rail is in *Power Good* status. The device fulfills a *Rail Sequence Off Dependency* status when the rail is in *Not Power Good* status. The device fulfills a *GPI Sequence On Dependency* status when the GPI pin is asserted. The device fulfills a *GPI Sequence Off Dependency* status when the GPI pin is de-asserted. The device fulfills a *GPO Sequence On Dependency* status when the logical sate of the GPO is TRUE. The device fulfills a *GPO Sequence Off Dependency* status when the logic state of the GPO is FALSE.

After the EN pin of a rail is asserted, if the rail voltage does not rise above *Power Good On* threshold within the *Maximum Turn-ON* time, a *Time On Max* fault occurs. Similarly, after the EN pin of a rail is de-asserted, if the rail voltage does not fall below 12.5% nominal output voltage within *Maximum Turn-OFF* time, a *Time Off Max* warning occurs.

Each rail can include a *Fault Shutdown Slaves* function. When a rail shuts down as a result of a fault, the associated slave rails also shut down. The device continues to monitor delays and dependencies of the slave rails during the shutdown process. Fault Shutdown Slaves cannot cascade. In other words, if a rail that is acting as a slave shuts down, the associated slave rails does not shut down.

Each rail can set *Sequencing On/Off Timeout* periods. The timeout periods begin to increment when a rail receives a turn-ON or a turn-OFF command as defined in *On/Off Config*. When the *Sequencing On/Off Timeout* period elapsed, the rail executes one of 3 actions including:

- Wait Indefinitely
- · Enable or Disable Rail
- Re-sequence (Sequencing On only)

Re-sequence is a series of actions that shuts down a rail and the Fault Shutdown Slaves, and then re-enables the rails according to sequence-on delay times and dependencies. The re-sequencing parameters can be configured in the **Other Config** tab, as shown in Figure 14.

Re-Sequencing Options							
☐ Enable Re-Sequence Abort If a rail fails to turn off during re-sequencing, stop the re-sequencing operation.							
Max Re-Sequences: 1 time ✓							
Time Between Re-Sequences: 0 ♠ msec							
From 0 to 32,256 milliseconds.							
Re-Sequence Rails Masks: If set, device will not check rail off status (rail's voltage below POWER GOOD OFF, and TOFF_MAX_WARN status bit) when performing resequence							
Rail #01 Rail #02 Rail #03 Rail #04 Rail #05 Rail #06 Rail #07 Rail #08							
Rail #09 Rail #10 Rail #11 Rail #12 Rail #13 Rail #14 Rail #15 Rail #16							
Rail #17 Rail #18 Rail #19 Rail #20 Rail #21 Rail #22 Rail #23 Rail #24							
Rail #25 Rail #26 Rail #27 Rail #28 Rail #29 Rail #30 Rail #31 Rail #32							
Uncheck All Check All							

Figure 14. Re-Sequencing Options (Global Configuration ► Misc Config)



A re-sequencing event can be repeated for one to approximately four times or unlimited times. The *Time Between Re-Sequences* period begins to increment when all the relevant rails are given *Not Power Good* statuses. When the time period elapses, a re-sequence event begins. When the *Enable Re-Sequence Abort* is checked, the re-sequence event aborts if any relevant rail triggers a *Max Turn Off* warning. However, the *Max Turn Off* warning does not stop an ongoing re-sequence event. If any rails at the re-sequence state are caused by a GPI fault response, the device suspends the entire re-sequence event until the GPI fault is physically clear.

It is also configurable to ignore the POWER_GOOD_OFF and TOFF_MAX_WARN status of a rail when performing re-sequencing if the corresponding bits are set.

After the Rail Sequence is configured, the GUI displays simulated sequence timing in the **Vout Config** tab. It demonstrates the dependencies among the rails. An example is shown in Figure 15. The rails power-on and power-off slew rates in Figure 15 are for demonstration purpose only.

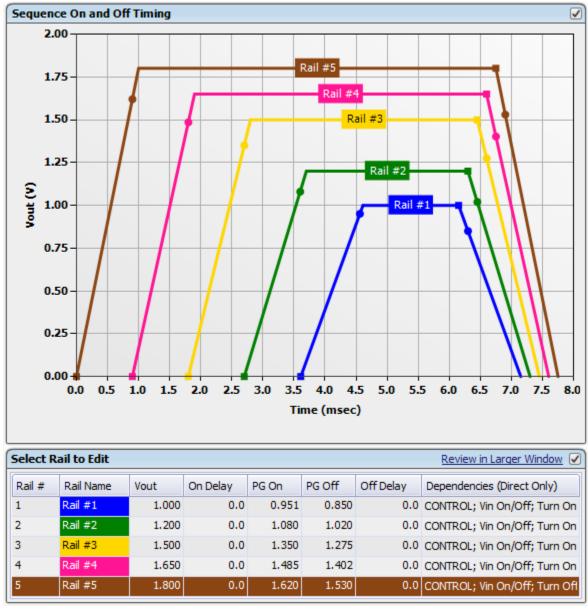


Figure 15. Simulated Sequence Timing Window (Rail Config)



8.4.4 Fault Responses Configuration

In the previous sections, various fault and warn notification thresholds have been configured to monitor voltage, current, temperature, and turn-ON time and turn-OFF time. When a fault threshold is reached, a fault event occurs. The device performs the following three actions in response of a fault event.

- Asserts the PMBus ALERT line
- Logs the fault event into nonvolatile memory (data flash), set status register bit
- · Executes fault responses defined by users

The Fault Responses can be configured under the Fault Responses and Limits tab. Figure 16 shows an example configuration window.

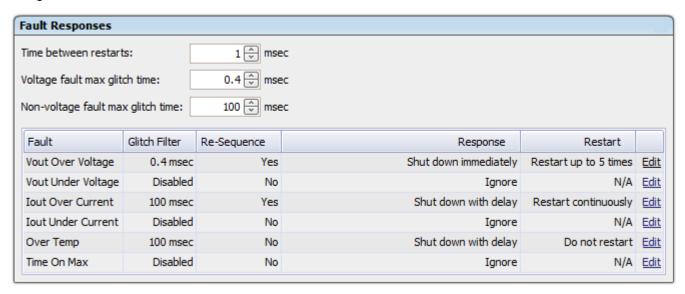


Figure 16. Fault Responses Configuration Window (Rail Configure ► Fault Responses)

A programmable glitch filter can be enabled or disabled for each type of fault. When a fault remains present after the glitch filter time expires, the device performs of the three selectable actions:

- · Log the fault and take no further action
- Log the fault and shut down the rail immediately
- Log the fault and shut down the rail with Turn Off Delay

After shutting down the rail, the device performs one of the three selectable actions:

- Do not restart the rail until a new turn-on command is received
- Restart the rail. If the restart is unsuccessful, retry up to a user-defined number of times (up to a maximum of 14) and then remain off until the fault is cleared
- Restart the rail. If the restart is unsuccessful, retry for an unlimited number of times unless the rail is commanded off by a signal defined in *On/Off Config*.

After the rail exhausts the restart attempts, Re-sequence can be initiated. (See also the *Rail Sequence Configuration* section).

Voltage, current, and temperature monitoring are based on results from the 12-bit ADC(AMON) and 8 DMON. All the voltage monitoring AMON and DMON channels are monitored every 400 µs for up to 32 channels. Current monitoring ADC channels are monitored at 200 µs per channel. Temperature monitoring ADC channels are monitored at approximately 4.17 ms per channel. The ADC results are compared with the programmed thresholds. The time to respond to an individual event is determined by when the event occurs within the ADC conversion cycle and the configured fault responses (glitch filters, time delays, and so forth).

GPI pins can also trigger faults if the GPI Fault Enable checkbox in Figure 12 is checked. The GPI Fault Responses options are the same as the Fault Responses discussed earlier in this section, with one exception: the GPI Fault Responses option does not support the retry action. An example configuration window is shown in Figure 17.



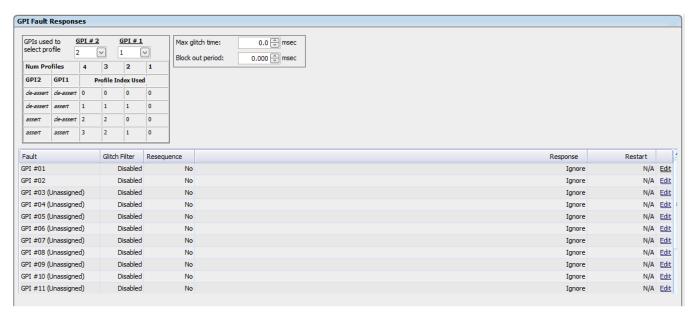


Figure 17. GPI Fault Responses Configuration Window (Rail Configure ▶ Fault Responses)

8.4.5 GPO Configuration

8.4.5.1 Command Controlled GPO

The UCD90320 device has 84 GPIO pins, all of which can be configured as Command Controlled GPOs. These GPOs are controlled by PMBus commands (GPIO_SELECT and GPIO_CONFIG) and can be used to control LEDs, enable switches, and so forth. Details on controlling a GPO using PMBus commands can be found in the UCD90320 Sequencer and System Health Controller PMBus Command Reference. The configuration window of Command Controlled GPO is under Pin Assignment tab. An example configuration window is shown in Figure 18.

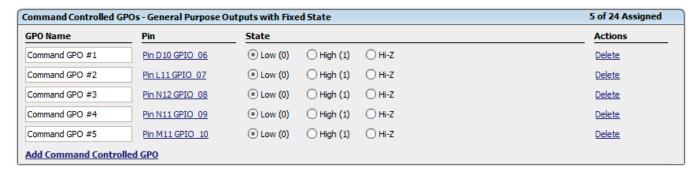


Figure 18. Command Controlled GPO Configuration Window (Hardware Configure ► Monitor and GPIO Pins Assignment)

8.4.5.2 Logic GPO

UCD90320 also has 16 dedicated Logic GPO (LGPO) pins. The configuration window is under Pin Assignment tab, as shown in Figure 19.



Logic Controlled GPOs - Ger	ogic Controlled GPOs - General Purpose Outputs with Programmble State Logic 5 of 12 Assigned									
GPO Name	Pin	Polarity	Mode	Configuration Summary	Actions					
Logic GPO #1	Pin C9 GPO 01	Active High	Actively Driven	Delay=0 ms * <no logic=""></no>	<u>Delete</u> <u>Configure</u>					
Logic GPO #2	Pin B9 GPO 02	Active High	Actively Driven	Delay=0 ms * <no logic=""></no>	<u>Delete</u> <u>Configure</u>					
Logic GPO #3	Pin A9 GPO 03	Active High	Actively Driven	Delay=0 ms * <no logic=""></no>	<u>Delete</u> <u>Configure</u>					
Logic GPO #4	Pin C8 GPO 04	Active High	Actively Driven	Delay=0 ms * <no logic=""></no>	<u>Delete</u> <u>Configure</u>					
Logic GPO #5	Pin D5 GPO 05	Active High	Actively Driven	Delay=0 ms * <no logic=""></no>	<u>Delete</u> <u>Configure</u>					
Add Logic Controlled GPO Move Selected Pins Up Move Selected Pins Down										

Figure 19. Logic GPO Configuration Window (Hardware Configure ► Monitor and GPIO Pins Assignment)

Each LGPO is controlled by an internal Boolean logic builder. Figure 20 shows the configuration interface of the Boolean logic builder. As shown, each Boolean logic builder has a top-level logic gate, which can be configured as AND, OR, or NOR gate with optional time delay. The inputs of the top-level logic gate are two AND paths. Each AND path can select a variety of inputs including GPI states, LGPO states, and rail statuses, as shown in Figure 21. The selectable rail statuses are summarized in Table 3. In Table 3, _LATCH type statuses stay asserted until cleared by a MFR PMBus command or by a specially configured GPI pin shown in Figure 12. See the UCD90320 Sequencer and System Health Controller PMBus Command Reference for complete definitions of rail-status types.

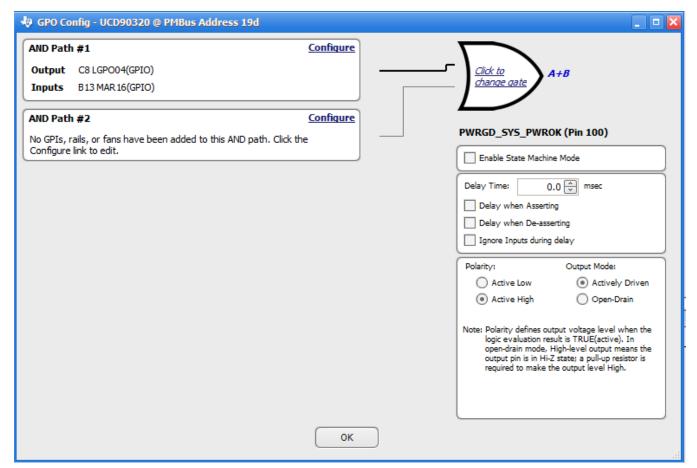


Figure 20. Boolean Logic Builder Interface



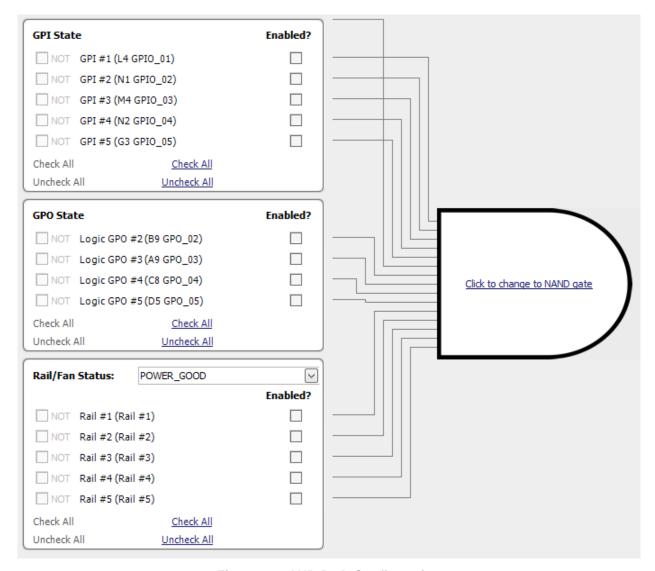


Figure 21. AND Path Configuration

Table 3. Selectable Rail Statuses in Boolean Logic Builder

Rail-Status Types							
POWER_GOOD	IOUT_OC_FAULT	TON_MAX_FAULT					
MARGIN_EN	IOUT_OC_WARN	TOFF_MAX_WARN					
MRG_LOW_nHIGH	IOUT_UC_FAULT	TON_MAX_FAULT_LATCH					
VOUT_OV_FAULT	IOUT_OC_FAULT_LATCH	TOFF_MAX_WARN_LATCH					
VOUT_OV_WARN	IOUT_OC_WARN_LATCH	SEQ_ON_TIMEOUT					
VOUT_UV_WARN	IOUT_UC_FAULT_LATCH	SEQ_OFF_TIMEOUT					
VOUT_UV_FAULT	TEMP_OT_FAULT	SEQ_ON_TIMEOUT_LATCH					
VOUT_OV_FAULT_LATCH	TEMP_OT_WARN	SEQ_OFF_TIMEOUT_LATCH					
VOUT_OV_WARN_LATCH	TEMP_OT_FAULT_LATCH	SYSTEM_WATCHDOG_TIMEOUT					
VOUT_UV_WARN_LATCH	TEMP_OT_WARN_LATCH	SYSTEM_WATCHDOG_TIMEOUT_LATCH					
VOUT_UV_FAULT_LATCH							



The POWER_GOOD status used by GPO evaluation is based on actual monitoring result from AMON or DMON pins. For a rail that does not have a voltage monitor pin, the POWER_GOOD status is used by sequencing purpose only, and is not used by GPO evaluation. Therefore during GPO evaluation, a rail without an AMON or DMON pin never reports POWER_GOOD status.

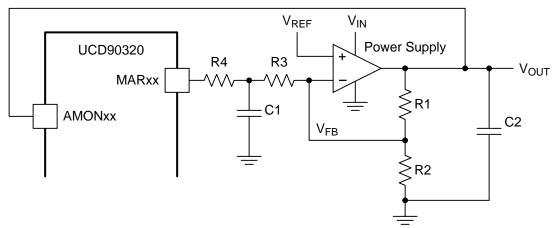
Each LGPO can be also configured as a simple state machine, as shown in Figure 16. In state machine mode, the top-level logic gate is omitted and only one of the two AND paths is evaluated. The output of the state machine is the result of the active AND path. The evaluation initially starts with AND Path #1. If the evaluation result is TRUE, AND Path #1 remains active until its evaluation result becomes FALSE. When the output associates with AND Path#1 becomes FALSE, AND Path #2 becomes active in the next evaluation cycle. AND Path #2 remains active until its evaluation result becomes TRUE, then AND Path #1 becomes active in the next evaluation cycle. An evaluation cycle is triggered when any input signal to the state machine changes state.

GPO1 to GPO8 outputs are internally synchronized to the same clock edge to enable them to change states together. GPO9 to GPO16 outputs are internally synchronized to enable them to change states together. GPO1 through GPIO8 and GPO9 through GPIO16 outputs status are updated within an time window between approximately 1 μ s and 3 μ s.

8.4.6 Margining Configuration

The UCD90320 device provides accurate closed-loop margining for up to 24 voltage rails. System reliability is improved through four-corner testing during system verification. During four-corner testing, the system operates at the minimum and maximum expected ambient temperature and with each power supply set to the minimum and maximum output voltage, commonly referred to as margining. Margining can be controlled via the PMBus interface using the OPERATION command or by configuring two GPI pins as margin-EN and margin-UP/DOWN inputs. The MARGIN_CONFIG command in the UCD90320 Sequencer and System Health Controller PMBus Command Reference user guide describes several margining options, including ignoring faults while margining and using closed-loop margining to trim the rail output voltage.

The device provides 24 PWM output pins for closed-loop margining. Figure 22 shows the block diagram of margining circuit. An external R-C network converts the PWM pulses into a DC margining voltage. The margining voltage is connected to the power supply feedback node through a resistor. The feedback node voltage is thus slightly pulled up or down by the margining voltage, causing the rail output voltage to change. The UCD90320 device monitors the rail output voltage. The device adjusts the margining PWM duty cycle accordingly such that the rail output voltage is regulated at the margin-high or margin-low voltages defined by the user. Effectively, margin control loop of the UCD90320 device overwrites the DC set point of the margined power supply. The margin control loop is extremely slow in order in order to not interfere with the power supply control loop.



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Figure 22. Block Diagram of Margining Circuit

Margining pins can be configured under the **Pin Assignment** tab, as shown in **Figure 23**. When not margining, the margin pin can operate in one of three modes:

- tri-state
- active trim



active duty cycle

Tri-state mode sets the margin pin to high-impedance. Active Trim mode performs a continuously trim the DC output voltage. Active Duty Cycle mode provides a user-defined fixed PWM duty cycle as shown in Figure 23.

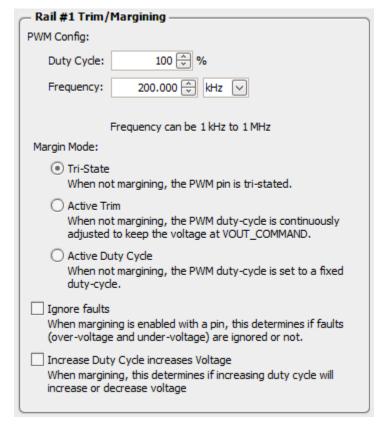


Figure 23. Margining Configuration Dropdown Window (Hardware Configuration ► Monitor and GPIO Pin Assignment)

8.4.7 Pin Selected Rail States Configuration

UCD90320 allows users to use up to 3 GPI pins to control up to 8 rail states. Each rail state enables and disables certain rails. This feature is useful to implement system low-power modes, such as those compliant with the Advanced Configuration and Power Interface (ACPI) specification. The Pin Selected States function can be configured under the Pin Selected States tab, as shown in Figure 24.

When a new state is presented on the GPI pins, and a rail is commanded to turn ON, it does so according to its sequence-on dependencies and delays. If a rail is commanded to turn OFF by a new state, it can be configured either immediately turn-OFF (Immediate OFF), or turn-OFF with its sequence-off dependencies and delays (Soft Off). If a rail is commanded to remain in the same ON state or OFF state, no action occurs.

The Pin Selected Rail States function is implemented by modifying OPERATION command. Therefore, in order to use this function to control rail states, the related rails must be configured to use OPERATION command in *On/Off Config* (shown in Figure 6).

The Pin Selected States feature always uses the first 3 configured GPI pins to select system states. When selecting a new system state, state changes on GPI pins must be completed within 1 μ s, otherwise an unintended system state may be selected. See the UCD90320 Sequencer and System Health Controller PMBus Command Reference for complete configuration settings of Pin Selected States.



Pin Selected I	Rail States Con	ifig									
GPI 2 GPIO_03 GPI #3	GPI 1 GPIO_02 GPI #2	GPI 0 GPIO_01 GPI #1	State	Enabled	Turn Off Mode	Rail #1	Rail #2	Rail #3	Rail #4	Rail #5	
De-Asserted	De-Asserted	De-Asserted	0	\checkmark	Immediate Off \vee	Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off ∨	All On All Off
De-Asserted	De-Asserted	Asserted	1	\checkmark	Soft Off	On 🗸	All On All Off				
De-Asserted	Asserted	De-Asserted	2		Immediate Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off ∨	All On All Off
De-Asserted	Asserted	Asserted	3		Immediate Off 🗸	On 🗸	On 🗸	On 🗸	On 🗸	On 🗸	All On All Off
Asserted	De-Asserted	De-Asserted	4		Immediate Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off ∨	All On All Off
Asserted	De-Asserted	Asserted	5		Immediate Off 🗸	On 🗸	On 🗸	On 🗸	On 🗸	On 🗸	All On All Off
Asserted	Asserted	De-Asserted	6		Immediate Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off 🗸	Off 🗸	All On All Off
Asserted	Asserted	Asserted	7		Immediate Off 🗸	On 🗸	On 🗸	On 🗸	On 🗸	On 🗸	All On All Off

Figure 24. Pin Selected States Configuration Window (Global Configuration ▶ Pin Selected Rail States)

8.4.8 Watchdog Timer

The UCD90320 device provides a watchdog timer (WDT). The WDT can be reset by toggling a watchdog input (WDI) pin. If WDI is not toggled within a programmed period, the WDT times out. As a result, a watchdog output (WDO) pin is asserted (generates a pulse) in order to provide a system-reset signal.

The WDI and WDO pins are GPIO pins and are only optional. The WDI can be replaced by SYSTEM_WATCHDOG_RESET command sent over PMBus. The WDO can be manifested through the Boolean Logic defined GPOs, or its function can be integrated into the system reset pin (RESET) configured in the system reset function. See also the *System Reset Function* section.

The WDT timer is programmable from 0.001 s to 258.048 s. See also the UCD90320 Sequencer and System Health Controller PMBus Command Reference user guide for details on configuring the watchdog timer.

After a timeout, the WDT can be restarted by toggling the WDI pin or by writing a SYSTEM_WATCHDOG_RESET command over PMBus. Figure 25 shows the watchdog timing waveforms.

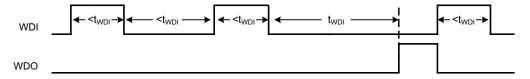


Figure 25. Watchdog Timer Operation Timing Diagram

The WDT can be active immediately at power up or after an initial wait time. These are the programmable wait times options that determine when the WDT operation begins.

- 100 ms
- 200 ms
- 400 ms
- 800 ms
- 1.6 s
- 3.2 s
- 6.4 s
- 12.8 s
- 25.6 s



- 51.2 s
- 102.4 s
- 204.8 s
- 409.6 s
- 819.2 s
- 1638.4 s

8.4.9 System Reset Function

The system reset function can generate a programmable system reset signal through a GPIO pin. The system reset signal is de-asserted when the selected rail voltages reach their respective Power Good On thresholds and the selected GPIs are asserted, plus a programmable delay time. These are the available options for the system-reset delay times.

- 0 ms
- 1 ms
- 2 ms
- 4 ms
- 8 ms
- 16 ms
- 32 ms
- 64 ms
- 128 ms
- 256 ms
- 512 ms
- 1.02 s
- 2.05 s
- 4.10s
- 8.19 s
- 16.38 s
- 32.8 s

The System Reset signal can be asserted immediately when any of the selected rail voltage falls below Power Good Off threshold, or any selected GPI is de-asserted. Alternatively, the System Reset signal can be configured as a pulse once Power Good On is achieved. An example in Figure 26 illustrates the difference of the two configurations. The pulse width can be configured between 0.001 s to 32.256 s. See the UCD90320 Sequencer and System Health Controller PMBus Command Reference for pulse width configuration details.

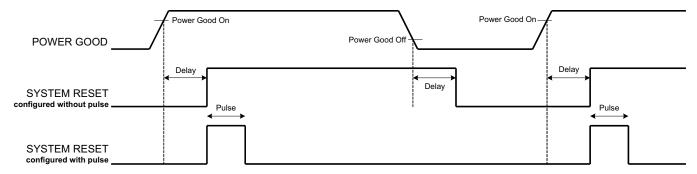


Figure 26. System Reset With and Without Pulse Setting (Active Low)

The *System Reset* signal can also integrate watchdog timer. An example is shown in Figure 27. In Figure 27, the first delay on *System Reset* is for the initial reset release that would enable the CPU once all necessary voltage rails are Power Good. The watchdog is configured with a Start Time and a Reset Time. If these times expire and timeout occurs, it means that the CPU providing the WDI signal is not operating. The *System Reset* signal is then toggled either using a Delay or GPI Tracking Release Delay to determine if the CPU recovers.



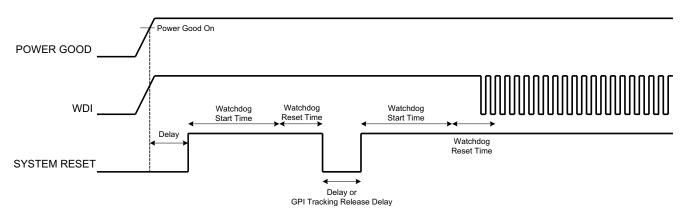


Figure 27. System Reset With Watchdog

The default state of the system reset pin (RESET) is assert. When the system reset function is configured incircuit through PMBus commands during normal operation, the (RESET) pin is briefly asserted by default, even if conditions for de-assert are present. This is because the firmware requires a finite time to examine the de-assert conditions.

8.4.10 Cascading Multiple Devices

Multiple UCD90320 devices can work together and coordinate to determine fault notification.

Up to 4 GPI pins can be configured as Fault Pins . Each Fault Pin is connected to a Fault Bus . Each Fault Bus is pulled up to 3.3 V by a 10-k Ω resistor. All the UCD90320 devices on the same Fault Bus are informed of the same fault condition. An example of Fault Pin connections is shown in Figure 28.

When there is no fault on a Fault Bus, the Fault Pins are digital input pins and listen to the Fault Bus. When one or multiple UCD90320 devices detect a rail fault, the corresponding Fault Pin is turned into active driven low state, pulling down the Fault Bus and informing all other UCD90320 devices of the corresponding fault. This way, a coordinated action can be taken across multiple devices. After the fault is cleared, the state of the Fault Pin is turned back to an input pin.

Any of the 24 rails can be assigned to one or multiple *Fault Pins*. The configuration window is shown in Figure 29.

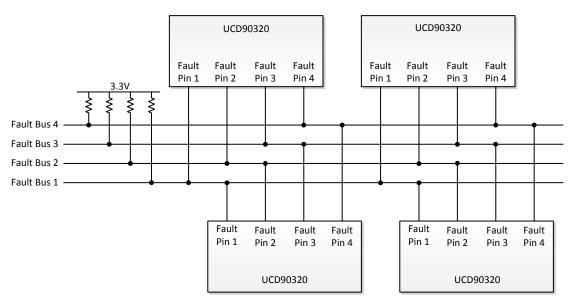


Figure 28. Example of Fault Pin Connections



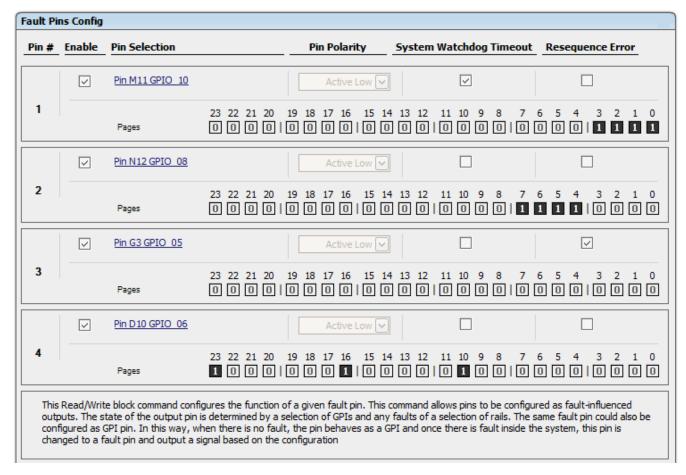


Figure 29. Example Fault Pins Configuration Window (Global Configuration ▶ Fault Pins Config)

These listed page-related faults have impact on the fault pin output. SYSTEM_WATCHDOG_TIMEOUT and RESEQUENCE_ERROR are optional to have impact on the fault pins.

- IOUT OC FAULT
- IOUT_UC_FAULT
- OT FAULT
- SEQ_OFF_TIMEOUT
- SEQ ON TIMEOUT
- TON MAX FAULT
- VOUT_OV_FAULT
- VOUT UV FAULT

A SYNC_CLK pin is used as a single-wire time synchronization method. A master chip constantly drives a 5-kHz clock to the slave devices. This function offers a precise time base for multiple UCD90320 devices to respond to the same fault event at the same time. The configuration window is shown in Figure 30. If the system uses only one UCD90320 device, it is recommended to configure this pin as master clock output. The SYNC_CLK output can be used as a time base for other purposes if needed.



Figure 30. SYNC_CLK Pin Configuration (Global Configuration ► Misc Config)



8.4.11 Rail Monitoring

UCD90320 monitors up to 24 analog inputs including voltages, current, and temperature and eight digital inputs for POWER_GOOD. Use either the Fusion GUI or a PMBus interface host to poll data from UCD90320. The Fusion GUI displays monitored rail voltage, current, and temperature information on the **Monitor** page, as shown in Figure 31. Use polling to debug system-level issues.

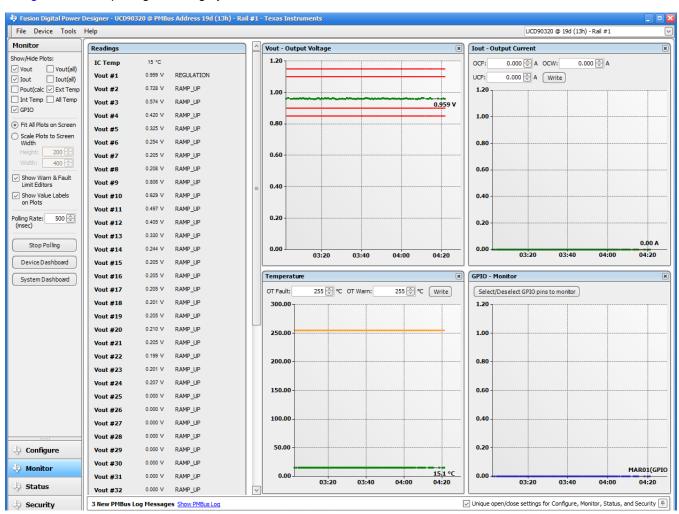


Figure 31. Fusion GUI Monitor Page



Table 4. Rail State Value Descriptions

RAIL STATE	VALUE	CONDITION FOR ENTERING RAIL STATE
IDLE	1	When a turn-ON condition is not met, or when rail is shut down due to a fault, or when the rail is waiting for the turn-ON period to resequence
SEQ_ON	2	Waits for the dependency to be met to assert the enable signal
START_DELAY	3	TON_DELAY to assert the enable signal
RAMP_UP	4	Enable signal is asserted and rail is approaching the power good threshold. If the power good threshold is set to 0 V, the rail stays at this state even if the monitored voltage is higher than 0 V.
REGULATION	5	When the monitoring voltage is higher than the power good threshold when the enable signal is asserted, rails stay at this state even if the voltage is below the power good threshold and continues as long as there is no fault action taken.
SEQ_OFF	6	Wait for the dependency to be met to de-assert the enable signal
STOP_DELAY	7	TOFF_DELAY to de-assert the enable signal
RAMP_DOWN	8	The enable signal is de-asserted and rail is ramping down. This state is available only if TOFF_MAX_WARN_LIMIT is not set to unlimited, or if the turn-off sequence is triggered by a fault action. The rail must not be under fault retry sequence to show this RAMP_DOWN state. Otherwise, the IDLE state is present.

8.4.12 Status Monitoring

The UCD90320 has status registers for each rail. Faults and warnings are logged into EEPROM memory to assist system troubleshooting. The status registers (Figure 32) and the fault log (Figure 33) can be accessed from Fusion GUI as well as the PMBus interface. See the *UCD90320 Sequencer and System Health Controller PMBus Command Reference*, and the PMBus Specification for detailed descriptions of each status register and supported PMBus commands.



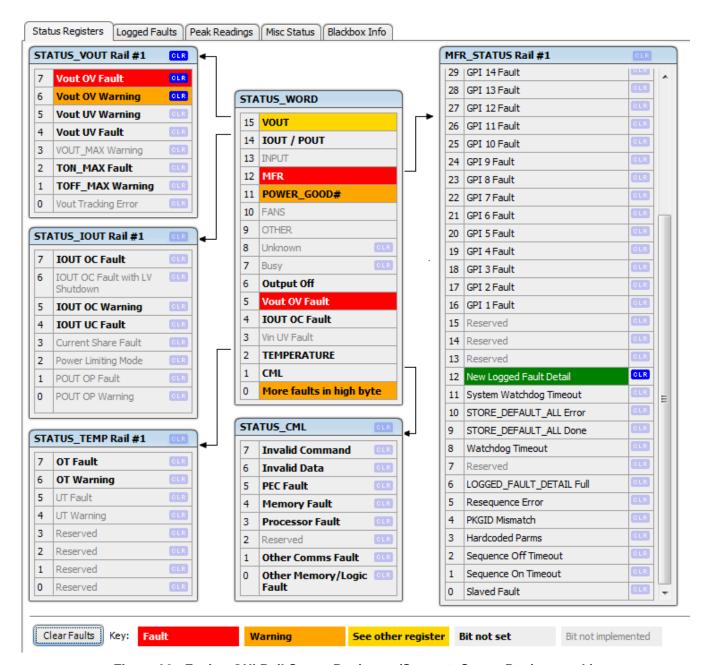


Figure 32. Fusion GUI Rail Status Registers (Status ► Status Registers tab)



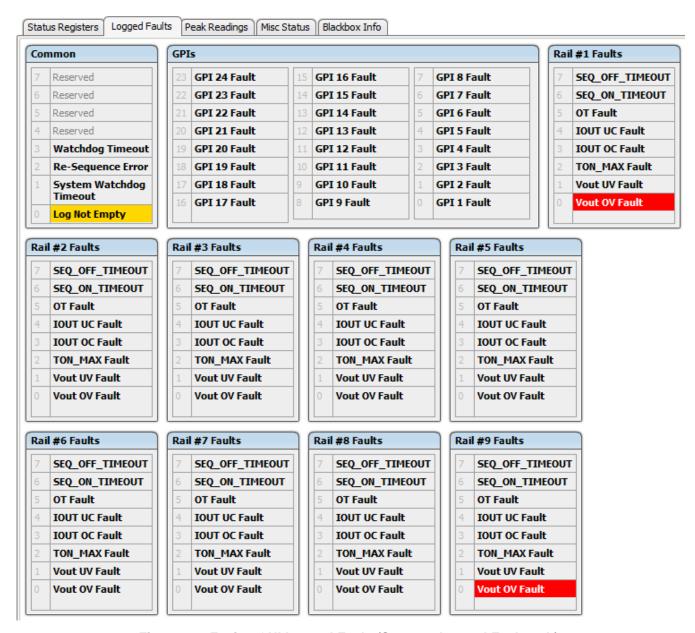


Figure 33. Fusion GUI Logged Faults(Status ▶ Logged Faults tab)

8.4.13 Data and Error Logging to EEPROM Memory

The UCD90320 provides fault log, device reset counter, and peak readings for each rail. To reduce stress on the EEPROM memory, a 30-second timer is started if a measured value exceeds the previously logged value. Only the highest value from the 30-second interval is written from RAM to EEPROM.

Faults are stored in EEPROM memory and are accessible over PMBus. Each logged fault includes the following information:

- Rail number
- Fault type
- Fault time since previous device reset
- Last measured rail voltage

The total number of device resets is also stored to EEPROM memory. The value can be reset using PMBus.



The run time clock value is logged into EEPROM when a power down is detected. This allows UCD90320 to preserve the run-time clock value through resets or power cycles.

It is also possible to update and calibrate the UCD90320 internal run-time clock via a PMBus host. For example, a host processor with a real-time clock could periodically update the UCD90320 run-time clock to a value that corresponds to the actual date and time. The host must translate the UCD90320 timer value back into appropriate units, based on the usage scenario chosen. See the REAL_TIME_CLOCK command in the UCD90320 Sequencer and System Health Controller PMBus Command Reference for more details.

8.4.14 Black Box First Fault Logging

The first fault in a system failure event is usually critical to diagnose the root cause. An innovative Black Box Fault Logging feature is introduced in UCD90320 to accelerate the debugging process. When UCD90320 detects the first fault, the device records and saves the status of each rail and I/O pin in a special area of the EEPROM reserved for this function. The device does not save the subsequent faults and monitoring statuses into the Black Box Fault Log, but instead records them into the standard fault log. The Black Box Fault Log must be cleared in order to acknowledge the next fault.

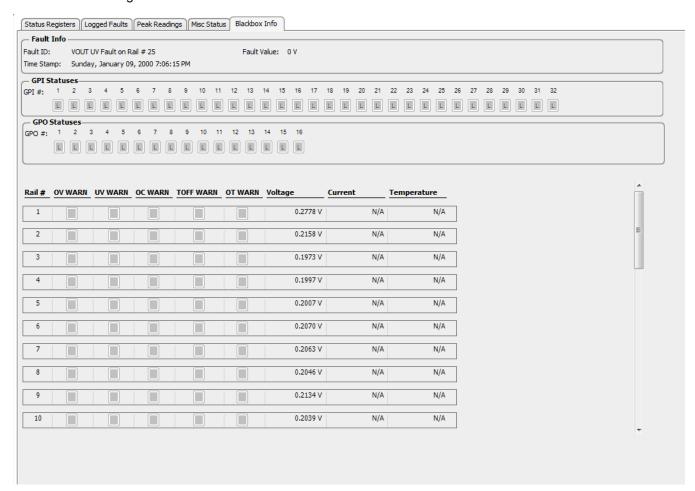


Figure 34. Black Box Fault Logging Window (Status ▶ Blackbox Info tab)

8.4.15 PMBus Address Selection

Three digital input pins are allocated to decode the PMBus address. At power up, UCD90320 detects the logic inputs of the three address pins to determine the configured PMBus address.



Table 5. PMBus Address Configuration	on
--------------------------------------	----

PMBUS_ADDR2	PMBUS_ADDR1	PMBUS_ADDR0	PMBus Address Selected		
L	L	L	17d	0010001b	
L	L	Н	19d	0010011b	
L	Н	L	23d	0010111b	
L	Н	Н	49d	0110001b	
Н	L	L	51d	0110011b	
Н	L	Н	113d	1110001b	
Н	Н	L	115d	1110011b	
Н	Н	Н	119d	1110111b	

8.4.16 ADC Reference

Using the V33A pin as ADC reference voltage by default provides a cost-effective solution. However, internal voltage reference has a higher Total Unadjusted Error. Also, voltage variations on the V33A pin affect ADC readings, such as when the device is powered down. In order to achieve better ADC accuracy, an external voltage reference can be connected to the VREFA+ and VREFA- pins. Ensure that the external reference voltage stays in regulation whenever V33D is above VBOR threshold. This limitation allows accurate ADC readings in full V33D operating range.

The external reference voltage level must be configured into the Fusion GUI to give correct ADC readings.

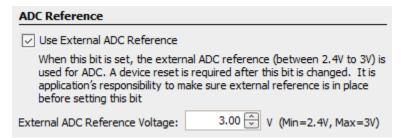


Figure 35. ADC Reference Configuration Window (Global Configuration ▶ Misc Config)

8.4.17 Device Reset

The UCD90320 device has an integrated power-on reset (POR) circuit which monitors the supply voltage. At power up, the POR detects the V33D pin voltage rise. When the V33D voltage is greater than V_{RESET} , the device comes out of reset.

The device can be forced into the reset state by an external circuit connected to the \overline{RESET} pin. A logic-low voltage on this pin for longer than t_{RESET} sets the device into reset state. The device comes out of reset within t_{IRT} after \overline{RESET} is released to logic-high level.

Any time the device comes out of reset, it begins an initialization routine that lasts typically 40 ms. A data flash checksum verification is performed at power up. If the checksum verification does not match, the device configuration settings are cleared, the PMBALERT pin is asserted, and a flag is set in the status register. A fault-log checksum verification in the EEPROM is also performed at power up. Each log entry includes the checksum verification status. Only a corrupted log entry is discarded. During the initialization routine, all I/O pins are held at high impedance state. At the end of initialization, the device begins normal operation as defined by the device configuration.

8.4.18 Brownout

The UCD90320 device triggers brownout event when the V33D pin voltage drops below the brownout threshold voltage, (V_{BOR}). During a brownout event, the device continues to write fault logs into the EEPROM that occurred before the brownout event. As the supply voltage continues to drop, the device fully shuts down when the V33D pin voltage is below the shutdown threshold voltage (V_{SHDN}). Any fault event that has not been written into the EEPROM before the device shutdown is lost.



In the scenario where several faults happen immediately before the brownout event, the device requires a capacitance of 500 μ s in order to write the first fault event into the EEPROM. The write function requires an additional 4 ms to write the Black Box fault log into the EEPROM. Therefore, in order to preserve at least the first fault log, user must provide enough local capacitance to maintain the V33D rail above VSHDN for 500 μ s (or 4.5ms with the Black Box fault log). Longer holdup time allows more fault events to be written into the EEPROM during brownout.

NOTE

The hold-up time is affected by V33D rail capacitance, the UCD90320 supply current and external circuits that source current from the rail (such as LEDs, load current on I/O pins, and other devices powered by the same rail).

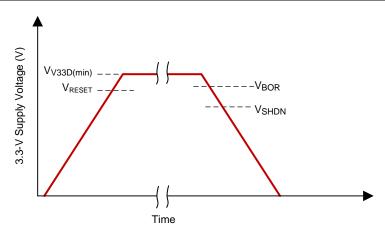


Figure 36. Reset and Brownout Thresholds

8.4.19 Internal Fault Management

The UCD90320 device verifies the firmware by using a checksum algorithm at each power up. If the checksum does not match, the device resets. If the device continues to reset, the SYNC_CLK pin outputs repeated pulses with an approximate 250-ms pulse width that can be observed externally.

The device performs a configuration checksum verification at power up. If the checksum does not match, the device discards all the configuration data. The PMBALERT pin is asserted and a flag is set in the status register.

A fault-log checksum verification in EEPROM is also performed at power up. Each log entry has a checksum. The device discards corrupted log entries.

If the internal firmware watchdog timer times out, the device resets. If the firmware program is corrupted, the device returns to a known state. This return function is normal, so all of the I/O pins are held in high-impedance while the device is in reset. The process confirms each parameter to ensure it falls within the acceptable range.

8.5 Device Configuration and Programming

UCD90320 devices include factory-installed sequencing and monitoring firmware. All I/O pins are pre-configured ad high-impedance, with no sequencing or fault-response operation. Use the Fusion GUI to configure the device on-line or off-line. Generate a configuration file after configuring the device and import that configuration into other UCD90320 devices.

The **Configuration Programming of UCD Devices** section of the Documentation & Help Center offers configuration and programming details and can be accessed under the Fusion GUI Help menu. In general, UCD90320 supports two programming methods:

• The PMBus command over PMBus and I²C method uses a PMBus host to program the device. The PMBus host can be either a host microcontroller or Fusion GUI tools. Each PMBus command sends a corresponding parameter(s) into the device. The new parameters are stored in its associated memory (RAM) location. After all the parameters are sent into the device, the PMBus host issues a special command, STORE_DEFAULT_ALL, which writes the RAM data into nonvolatile memory (data flash). Fusion GUI normally uses this method to configure a device. If using Fusion GUI tools for on-board programming, the



Device Configuration and Programming (continued)

Fusion GUI tools must have ownership of the PMBus/I²C bus of the target board.

 The data flash image over PMBus and I²C method uses the Fusion GUI to export a data flash image in Intel Hex or S-record format. The image file can be directly downloaded into the device's data flash via PMBus and I²C using Fusion GUI tools or a dedicated device programmer. The new configuration takes effect after a device reset.

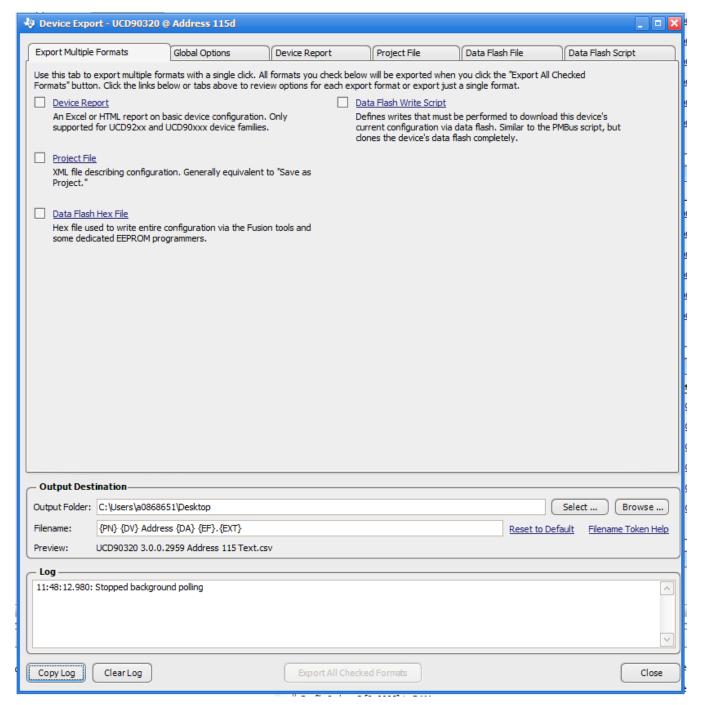


Figure 37. Fusion GUI Configuration Export Tool



Device Configuration and Programming (continued)

The UCD90320 must be powered when it is being programmed via the PMBus or I^2C interface. The PMBus clock and data pins must be accessible and must be pulled high to the same V33D supply that powers the device, with pullup resistors between 1 k Ω and 2 k Ω . Do not introduce additional bus capacitance less than 100 pF. When programming multiple UCD90320 devices over I^2C , programming must be done individually. Specifically, the clock and data lines must be multiplexed such that only one device is written by the programmer at a time. Alternatively, the socket must assign different addresses to each device. To program a small number of devices at one time, use a socketed board with an I^2C header with the standard Fusion GUI or manufacturing GUI. Programming also can be done using a single device test fixture.

To update the device configuration in an operating system, the PMBus command method can be used to update thresholds, timeout periods, and dependencies while the system is operating. Because the new configuration is written into RAM, it takes effect immediately. However, pin-function-related configurations (change of rails, change of GPI/GPO functions for example) may not work correctly until after a device reset. This delay may indicate a problem in an operating system. For example, undesired states in the GPI, GPO, or RESET pin may disable rails that provide power to the UCD90320, and thus terminate the programming process before it is completed. Using the data flash image method can overcomes this problem by directly writing new configuration into the data flash. This method allows a full configuration while the system is operating. It is not required to reset the device immediately but the UCD90320 continues to operate based on previous configuration until a device reset.

The JTAG port is compatible with IEEE Standard 1149.1-1990, *Test-Access Port and Boundary Scan Architecture* specification. The UCD90320 device supports boundary scan. The UCD90320 device supports does not support configuration programming via JTAG.



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The UCD90320 device can be used to sequence, monitor up to 32 rails and margin up to 24 voltage rails. With the cascading feature, up to four UCD90320 devices can manage up to 128 rails and record synchronized fault responses. Typical applications include automatic test equipment, telecommunication and networking equipment, servers and storage systems. Device configuration can be performed using the Fusion GUI provided by TI. No coding skill is required.

9.2 Typical Application

Figure 38 shows a simplified system diagram. For simplification, this diagram shows only three rails, but each UCD90320 device can manage up to 32 rails.



Typical Application (continued)

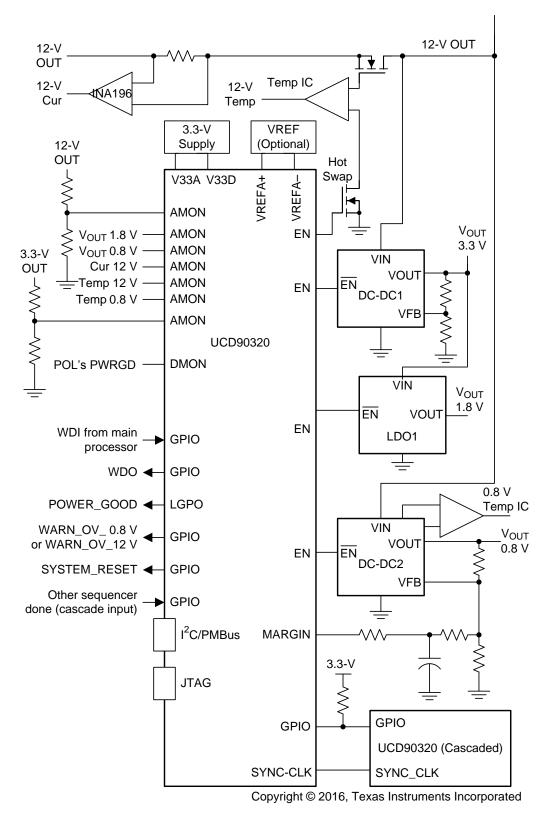


Figure 38. Simplified System Diagram

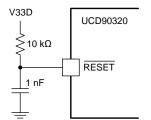


Typical Application (continued)

9.2.1 Design Requirements

UCD90320 requires decoupling capacitors on the V33D, V33A, BPCAP, and (if applicable) VREFA+ pins. The capacitance values for V33A, BPCAP and VREFA+ are specified in the Electrical Characteristics table. Consider these capacitor design configurations as options.

- Three 1-μF X7R ceramic capacitors in parallel with two 0.1-μF X7R ceramic capacitors for BPCAP decoupling
- Two 1-μF X7R ceramic capacitors in parallel with four 0.1-μF X7R ceramic capacitors and two 0.01-μF X7R ceramic capacitors for V33D decoupling
- One 1-μF X7R ceramic capacitor in parallel with one 0.1-μF X7R ceramic capacitor and one 0.01-μF X7R ceramic capacitor for V33A decoupling. A 1-Ω resistor can placed between V33D and V33A to decouple the noise on V33D from V33A.
- One 1-μF X7R ceramic capacitor in parallel with one 0.01-μF X7R ceramic capacitor for VREFA+ decoupling (if used)
- Place decoupling capacitors as close to the device as possible.
- If an application does not use the RESET signal, the RESET pin must be tied to V33D, either by direct connection to the nearest V33D pin (Pin F10), or by a R-C circuit as shown in Figure 39. The R-C circuit in Figure 39 can be also used to delay reset at power up. If an application uses the RESET external pin, the trace of the RESET signal must be kept as short as possible. Be sure to place any components connected to the RESET signal as close to the device as possible.
- TI recommends to maintain at least 200-Ω resistance between a low-impedance analog input and a AMON pin. For example, when monitoring a rail voltage without resistor divider, it is recommended to place a 200-Ω resistor at the AMON pin, as shown in Figure 40.



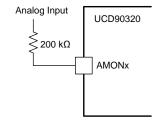


Figure 39. RESET Pin With R-C Network

Figure 40. Example of Analog Inputs

9.2.2 Detailed Design Procedure

The Fusion GUI can be used to design the device configuration online or offline (with or without a UCD90320 device connected to the computer). In offline mode, the Fusion GUI prompts the user to create or open a project file (.xml) at launch. In online mode, the Fusion GUI automatically detects the device via the PMBus interface and extracts the configuration data from the device. A USB Interface Adapter EVM available from TI is required to connect Fusion GUI to PMBus.

The general design steps include. Details of the steps are described in the *Detailed Description* section, and are easily accessed within the Fusion GUI.

- 1. Rail setup
- 2. Rail monitoring configuration
- GPI configuration
- 4. Rail sequence configuration
- 5. Fault response configuration
- 6. GPO configuration
- 7. Margining configuration
- 8. Other configurations including but not limited to
 - Pin Selected Rail States
 - Watchdog Timer
 - System Reset

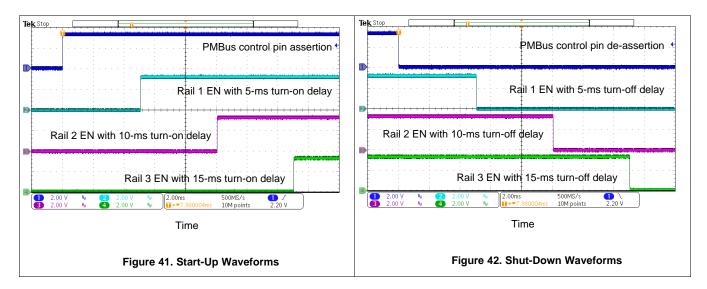


Typical Application (continued)

- Sync Clock
- Fault Pins

Click **Write to Hardware** to apply the changes. In online mode, the then click **Store RAM to Flash** to permanently store the new configuration into the data flash of the device.

9.2.3 Application Curves



10 Power Supply Recommendations

Power the UCD90320 device from a 3.3-V power supply.

If internal reference is used, V33A acts as ADC reference and is assumed to be exactly 3.3 V. Any input voltage deviation from 3.3 V introduces an error to ADC reference and to the ADC results. Therefore, the 3.3-V power supply must be tightly regulated and allow only a very small voltage fluctuation (including voltage ripple and voltage deviation caused by load transients).

If external reference is used, the 3.3-V power supply needs to meet only the minimum requirements specified in the Recommended Operating Conditions table and the Electrical Characteristics table.

11 Layout

11.1 Layout Guidelines

- Place the decoupling capacitors as close as possible to the device.
- Connect the BPCAP decoupling capacitors as close as possible to pin D6.
- MARGIN pins output PWM signals that have fast-edges. Route these signals away from sensitive analog signals. It is a good practice to place resistor R4 and capacitor C1 (as shown in Figure 22) as close as possible to the MARGIN pin, minimizing the propagation distance of the fast-edge PWM signals on the PCB.
- Resistor R3 can be placed near the power supply feedback node to isolate the feedback node from noise sources on the PCB. If resistor R4 and capacitor C1 cannot be located close to the MARGIN pin, add a termination resistor in series with a value between $20-\Omega$ and $33-\Omega$. Locate it near the MARGIN pin.

11.2 Layout Example

The UCD90320 device is available in a 169-pin BGA package. If the design calls for the device to be mounted on the top layer, decoupling capacitors can be placed on the bottom layer to allow room for top-layer trace routing. The layout example below describes this strategy. Figure 43 shows bottom-layer component placement from top-view. In addition to Figure 43, consider these important suggestions.



Layout Example (continued)

- 1. Use a uniform ground plane to connect DVSS, AVSS, and VREFA-pins.
- 2. Connect all four BPCAP pins to a common internal-layer copper area.
- 3. AVSS and VREFA- pins can be connected to a common internal-layer copper area.

Figure 43 shows a typical application with the UCD90320 device mounted on the top layer and the components placed on the bottom layer.

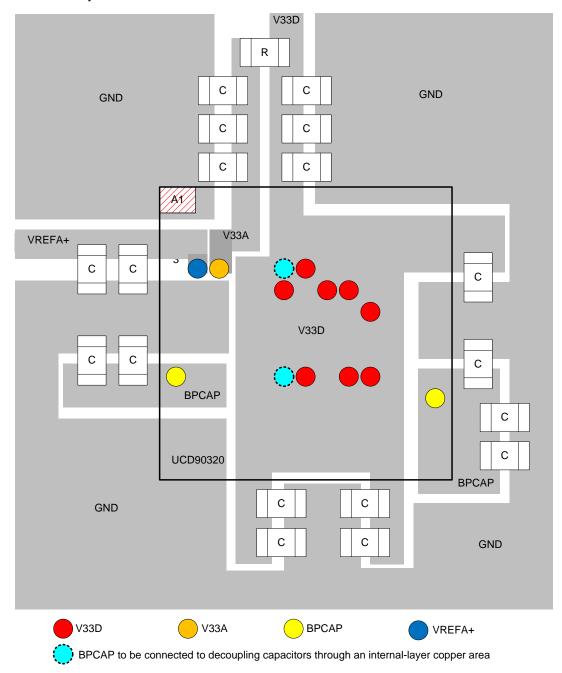


Figure 43. Layout Example



12 器件和文档支持

12.1 社区资源

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12.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 机械、封装和可订购信息

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PACKAGE OPTION ADDENDUM

5-Oct-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
UCD90320ZWSR	ACTIVE	NFBGA	ZWS	169	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	UCD90320	Samples
UCD90320ZWST	ACTIVE	NFBGA	ZWS	169	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	UCD90320	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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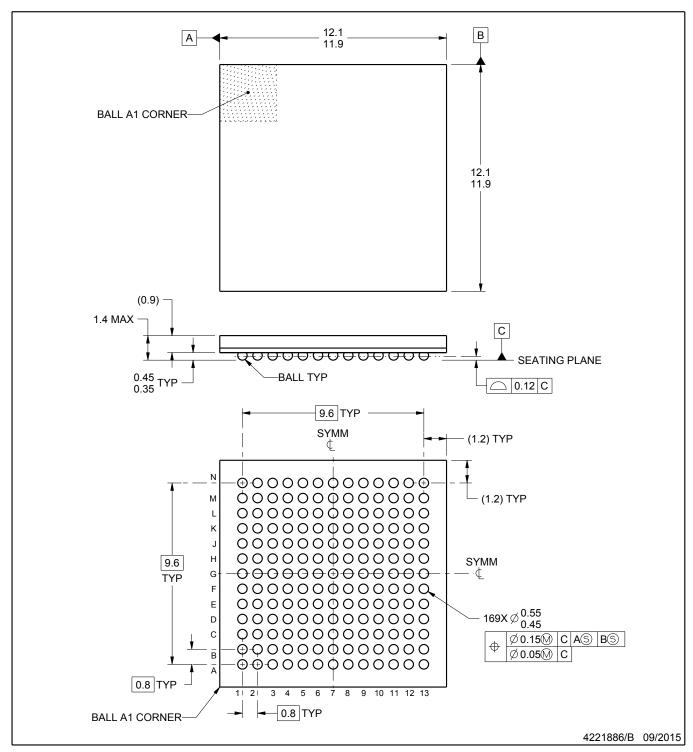
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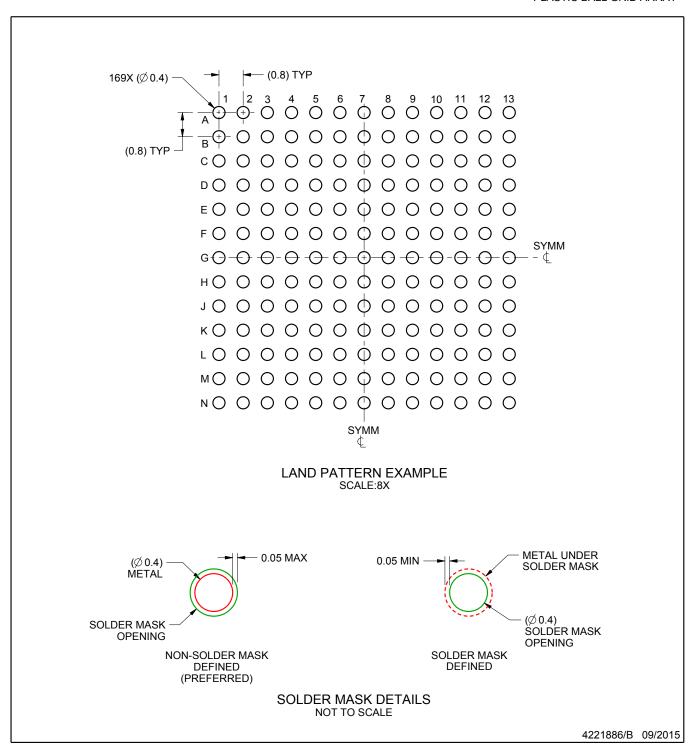


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



PLASTIC BALL GRID ARRAY

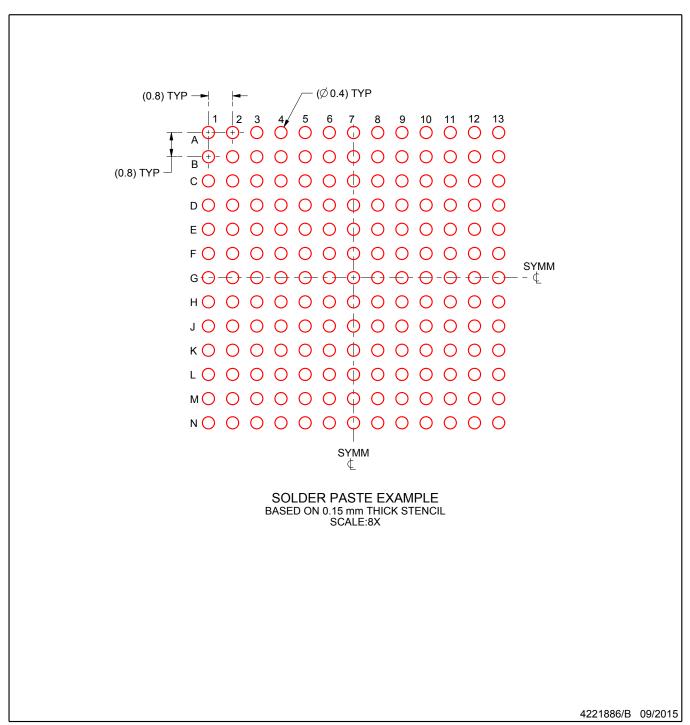


NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For information, see Texas Instruments literature number SSZA002 (www.ti.com/lit/ssza002).



PLASTIC BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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